











LMX2572LP

SNAS764 - MAY 2018

## LMX2572LP 2-GHz Low Power Wideband RF Synthesizer With FSK Modulation

#### **Features**

- Output Frequency: 12.5 MHz to 2 GHz
- Low Power Consumption: 70 mA at 3.3-V Supply
- -124-dBc/Hz Phase Noise at 100-kHz Offset With 800-MHz Carrier
- PLL Figure of Merit: -232 dBc/Hz
- PLL Normalized 1/f Noise: -123.5 dBc/Hz
- 32-Bit Fractional-N Divider
- Remove Integer Boundary Spurs With Programmable Input Multiplier
- Synchronization of Output Phase Across Multiple
- Support for Ramp and Chirp Functions
- Support for FSK Direct Digital Modulation
- Two Programmable Output Power Level **Differential Outputs**
- Fast VCO Calibration Speed: < 20 µs
- Single 3-V to 3.5-V Power Supply

#### Applications

- Test and Measurement Equipment
- Digital 2-Way Radios
- Low Power Radio Communication Systems
- Satellite Communication
- Wireless Microphones
- **Propriety Wireless Connectivity**
- MIMO
- High-Speed Data Converter Clocking

#### 3 Description

The LMX2572LP is a low-power, high-performance wideband synthesizer that can generate one frequency from 12.5 MHz to 2 GHz without the use of an internal doubler. The PLL delivers excellent performance while consuming just 70 mA from a single 3.3-V supply.

For applications like digital mobile radio (DMR) and wireless microphones, the LMX2572LP supports FSK modulation. Discrete level FSK and pulse-shaping FSK are supported. Direct digital FSK modulation is achievable through programming or pins.

The LMX2572LP allows users to synchronize the output of multiple devices and also enables applications that need deterministic delay between input and output. The LMX2572LP provides an option to adjust the phase with fine granularity to account for delay mismatch on the board or within devices. A frequency ramp generator can synthesize up to two segments of ramp in an automatic ramp generation option or a manual option for maximum flexibility. The fast calibration algorithm allows the user to change frequencies faster than 20 us.

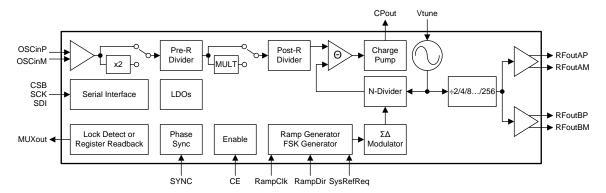
The LMX2572LP integrates LDOs from a single 3.3-V supply, thus eliminating the need for onboard lownoise LDOs.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)	
LMX2572LP	VQFN (40)	6.00 mm × 6.00 mm	

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### **Functional Block Diagram**





## **Table of Contents**

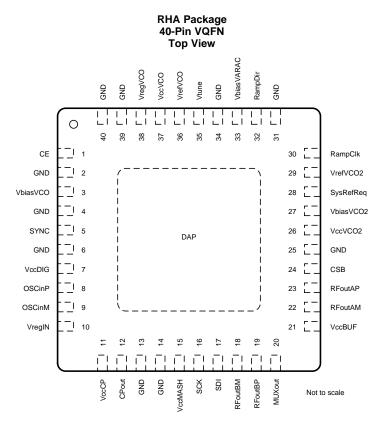
1	Features 1	7.5 Programming 1
2	Applications 1	7.6 Register Maps2
3	Description 1	8 Application and Implementation 59
4	Revision History2	8.1 Application Information 5
5	Pin Configuration and Functions3	8.2 Typical Application6
6	Specifications4	8.3 Do's and Don'ts
	6.1 Absolute Maximum Ratings	9 Power Supply Recommendations
	6.2 ESD Ratings	10 Layout 73
	6.3 Recommended Operating Conditions	10.1 Layout Guidelines
	6.4 Thermal Information5	10.2 Layout Example7
	6.5 Electrical Characteristics5	11 Device and Documentation Support 74
	6.6 Timing Requirements7	11.1 Device Support7
	6.7 Timing Diagrams	11.2 Documentation Support
	6.8 Typical Characteristics9	11.3 Receiving Notification of Documentation Updates 7
7	Detailed Description	11.4 Community Resources7
	7.1 Overview	11.5 Trademarks7
	7.2 Functional Block Diagram 12	11.6 Electrostatic Discharge Caution
	7.3 Feature Description	11.7 Glossary
	7.4 Device Functional Modes	12 Mechanical, Packaging, and Orderable Information

## 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	VERSION	NOTES
May 2018	*	Initial Release

## 5 Pin Configuration and Functions



**Pin Functions** 

	PIN	1/0	DECODINE	
NAME	NO.	I/O	DESCRIPTION	
CE	1	Input	Chip enable. High impedance CMOS input. 1.8-V to 3.3-V logic. Active HIGH powers on the device.	
CPout	12	Output	Charge pump output. Place C1 of loop filter close to this pin.	
CSB	24	Input	SPI latch. High impedance CMOS input. 1.8-V to 3.3-V logic.	
DAP	_	Ground	RF ground.	
	2, 4, 25, 31, 34, 39	Ground	VCO ground.	
GND	6, 14, 40	Ground	Digital ground.	
13		Ground	Charge pump ground.	
MUXout	20	Output	Multiplexed output pin. Configurable between lock detect and register readback.	
OSCinM	9	Input	Reference input clock (–). High impedance self-biasing pin. Requires AC-coupling.	
OSCinP	8	Input	Reference input clock (+). High impedance self-biasing pin. Requires AC-coupling.	
RampClk	30	Input	Ramp trigger in automatic ramping mode or ramp clock in manual ramping mode. Can also be used as FSK I2S clock input. High impedance CMOS input. 1.8-V to 3.3-V logic.	
RampDir	32	Input	Ramp trigger in automatic ramping mode or ramp segment selection in manual ramping mode. Can also be used as FSK I2S data input. High impedance CMOS input. 1.8-V to 3.3-V logic.	
RFoutAM	22	Output	Differential output A (–). Low impedance output. Requires AC-coupling.	
RFoutAP	23	Output	Differential output A (+). Low impedance output. Requires AC-coupling.	
RFoutBM	18	Output	Differential output B (–). Low impedance output. Requires AC-coupling.	
RFoutBP	19	Output	Differential output B (+). Low impedance output. Requires AC-coupling.	
SCK	16	Input	SPI clock. High impedance CMOS input. 1.8-V to 3.3-V logic.	



#### Pin Functions (continued)

PI	PIN I/		DECODINE	
NAME	NO.	1/0	DESCRIPTION	
SDI	17	Input	SPI data. High impedance CMOS input. 1.8-V to 3.3-V logic.	
SYNC	5	Input	Phase synchronization trigger. Configurable to accept CMOS input (1.8-V to 3.3-V logic) or differential input.	
SysRefReq	28	Input	FSK I2S Frame Sync input. High impedance CMOS input. 1.8-V to 3.3-V logic.	
VbiasVARAC	33	Bypass	VCO Varactor bias. Connect a 10-μF decoupling capacitor to VCO ground.	
VbiasVCO	3	Bypass	VCO bias. Connect a 470-nF (X7R) decoupling capacitor to VCO ground as close to this pin as possible.	
VbiasVCO2	27	Bypass	VCO bias. Connect a 100-nF (X7R) decoupling capacitor to VCO ground.	
VccBUF	21	Supply	Supply for output buffers. Connect a 0.1-µF decoupling capacitor to RF ground.	
VccCP	11	Supply	Supply for charge pump. Connect a 0.1-µF decoupling capacitor to charge pump ground.	
VccDIG	7	Supply	Digital power supply. Connect a 0.1-µF decoupling capacitor to digital ground.	
VccMASH	15	Supply	Digital power supply. Connect a 1-µF decoupling capacitor to digital ground.	
VccVCO	37	Supply	Supply for VCO. Connect a 1-µF decoupling capacitor to VCO ground.	
VccVCO2	26	Supply	Supply for VCO. Connect a 1-µF decoupling capacitor to VCO ground.	
VrefVCO	36	Bypass	VCO supply reference. Connect a 10-µF decoupling capacitor to VCO ground.	
VrefVCO2	29	Bypass	VCO supply reference. Connect a 10-µF decoupling capacitor to VCO ground.	
VregIN	10	Bypass	Input reference path regulator output. Connect a 1-µF decoupling capacitor to RF ground as close to this pin as possible.	
VregVCO	38	Bypass	VCO regulator node. Connect a 10-nF decoupling capacitor to VCO ground.	
Vtune	35	Input	VCO tuning voltage input. Connect a 1.5-nF or more capacitor to VCO ground. See Extent Loop Filter for details.	

## 6 Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
$V_{CC}$	Power supply voltage	-0.3	3.6	V
V <sub>IN</sub>	IO input voltage		$V_{CC} + 0.3$	V
$T_J$	Junction temperature		150	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Rating may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Condition. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	\/
V <sub>(ESD)</sub>	Electrostatic discriarge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins (2)	±500	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
T <sub>A</sub>	Ambient temperature	-40	85	ů
$T_{J}$	Junction temperature		125	°C

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 6.4 Thermal Information

		LMX2572LP	
	THERMAL METRIC <sup>(1)</sup>	RHA (VQFN)	UNIT
		40 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	25.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	14.4	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	8	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	0.2	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	7.9	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	1.2	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application

#### 6.5 Electrical Characteristics

3.0 V  $\leq$  V<sub>CC</sub>  $\leq$  3.5 V.  $-40^{\circ}$ C  $\leq$  T<sub>A</sub>  $\leq$  85°C. Typical values are at V<sub>CC</sub> = 3.3 V. 25°C (unless otherwise noted).

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
POWER SU	JPPLY				
V <sub>CC</sub>	Supply voltage		3 3.3	3.5	V
	0 1 .	f <sub>OSCin</sub> = 20 MHz; f <sub>PD</sub> = 40 MHz <sup>(1)</sup>	70		
I <sub>CC</sub>	Supply current	f <sub>OSCin</sub> = 100 MHz; f <sub>PD</sub> = 100 MHz <sup>(2)</sup>	74.5		mA
I <sub>CC</sub> PD	Power down current		2.5		
INPUT SIG	NAL PATH				
,	000: :	OSC_2X = 0 (Doubler bypassed)	5	250	
f <sub>OSCin</sub>	OSCin input frequency	OSC_2X = 1 (Doubler enabled)	5	125 MHz	MHZ
.,	(3)	Single-ended input buffer	0.3	3.6	.,
$V_{OSCin}$	OSCin input voltage (3)	Differential input buffer	0.15	1	V
f <sub>MULTin</sub>	Multiplier input frequency	NULT - 0	10	40	
f <sub>MULTout</sub>	Multiplier output frequency	MULT ≥ 3	60	150	MHz
PLL			-	ļ.	
	(4)	Integer channel	0.25	250	
,		1 <sup>st</sup> and 2 <sup>nd</sup> order modulator	5	200	MHz
f <sub>PD</sub>	Phase detector frequency <sup>(4)</sup>	3 <sup>rd</sup> order modulator	5	160	
		4 <sup>th</sup> order modulator	5	120	
		CPG = 1	625		
		CPG = 2	1250		
I <sub>CPout</sub>	Charge pump current	CPG = 3	1875		μΑ
		CPG = 15	6875		
PN <sub>PLL_1/f</sub>	Normalized PLL 1/f noise <sup>(5)</sup>		-123.5		
	(5)	Integer channel <sup>(6)</sup>	-232		dBc/Hz
PN <sub>PLL_Flat</sub>	Normalized PLL noise floor (5)	Fractional channel <sup>(7)</sup>	-232		
vco					
f <sub>VCO</sub>	VCO frequency		3200	6400	MHz

<sup>(1)</sup>  $I_{CP} = 2.5 \text{ mA}$ ;  $f_{VCO} = 3.2 \text{ GHz}$ ;  $f_{OUT} = 400 \text{ MHz}$ ;  $P_{OUT} = -3 \text{ dBm}$ ;  $OSC_2X = 1$ ; MULT = 1; one RF output. (2)  $I_{CP} = 2.5 \text{ mA}$ ;  $f_{VCO} = 3.2 \text{ GHz}$ ;  $f_{OUT} = 400 \text{ MHz}$ ;  $P_{OUT} = -3 \text{ dBm}$ ;  $OSC_2X = 0$ ; MULT = 1; one RF output.

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See OSCin Configuration for definition of OSCin input voltage.

For lower VCO frequencies, the N-divider minimum value can limit the phase detector frequency.

Measured with a clean OSCin signal with a high slew rate using a wide loop bandwidth. The noise metrics model the PLL noise for an infinite loop bandwidth as: PLL\_Total = 10\*log[10<sup>(PLL\_Flat/10)</sup>+10<sup>(PLL\_Flicker/10)</sup>]; PLL\_Flat = PN1 Hz + 20\*log(N) + 10\*log(f<sub>PD</sub>); PLL\_Flicker = PN10 kHz - 10\*log(Offset/10 kHz) + 20\*log(f<sub>DUT</sub>/1 GHz)

<sup>(6)</sup>  $f_{OSCin} = 200 \text{ MHz}$ ;  $f_{PD} = 100 \text{ MHz}$ ;  $f_{VCO} = 6 \text{ GHz}$ 

 $f_{OSCin}$  = 200 MHz;  $f_{PD}$  = 100 MHz;  $f_{VCO}$  = 6.001 GHz; Fractional denominator = 1000.

#### TEXAS INSTRUMENTS

#### **Electrical Characteristics (continued)**

 $3.0 \text{ V} \le \text{V}_{\text{CC}} \le 3.5 \text{ V}, -40 ^{\circ}\text{C} \le \text{T}_{\text{A}} \le 85 ^{\circ}\text{C}.$  Typical values are at  $\text{V}_{\text{CC}} = 3.3 \text{ V}, 25 ^{\circ}\text{C}$  (unless otherwise noted).

	PARAMETER	TEST CONDITION	S	MIN TYP	MAX	UNIT	
			10 kHz	-106			
		f <sub>OUT</sub> = 425 MHz	100 kHz	-129			
		$(f_{VCO} = 3.4 \text{ GHz})$	1 MHz	-149			
			10 MHz	-153.5			
			10 kHz	-105.5			
		f <sub>OUT</sub> = 487.5 MHz	100 kHz	-129			
		(f <sub>VCO</sub> = 3.9 GHz)	1 MHz	-149.5			
			10 MHz	-152.5			
			10 kHz	-104.5			
		f <sub>OUT</sub> = 550 MHz	100 kHz	-129			
		(f <sub>VCO</sub> = 4.4 GHz)	1 MHz	-149			
<b>5.</b>	0 1 1/00 1		10 MHz	-153			
$PN_{VCO}$	Open loop VCO phase noise		10 kHz	-103		dBc/Hz	
		f <sub>OUT</sub> = 612.5 MHz	100 kHz	-128			
		$(f_{VCO} = 4.9 \text{ GHz})$	1 MHz	-148.5			
			10 MHz	-154			
		f <sub>OUT</sub> = 675 MHz (f <sub>VCO</sub> = 5.4 GHz)	10 kHz	-102.5			
			100 kHz	-127			
			1 MHz	-147.5			
			10 MHz	-154			
		$f_{OUT} = 737.5 \text{ MHz}$ ( $f_{VCO} = 5.9 \text{ GHz}$ )	10 kHz	-102			
			100 kHz	-126.5			
			1 MHz	-147			
			10 MHz	-153			
		f <sub>VCO</sub> = 3.4 GHz		39			
		f <sub>VCO</sub> = 3.9 GHz		44		-	
		f <sub>VCO</sub> = 4.4 GHz		55		MHz/V	
K <sub>VCO</sub>	VCO gain	f <sub>VCO</sub> = 4.9 GHz		60			
		$f_{VCO} = 5.4 \text{ GHz}$		69			
		$f_{VCO} = 5.9 \text{ GHz}$		62			
			No assist	130			
t <sub>VCOcal</sub>	VCO calibration-time (8)	f <sub>OSCin</sub> = f <sub>PD</sub> = 100 MHz; Switch between 3.2 GHz and 6.4 GHz	Partial assist	50		μs	
Vocal		VCO frequency	Full assist	5		•	
ΔT <sub>CL</sub>	Allowable temperature drift <sup>(9)</sup>	VCO not being re-calibrated, -40			125	°C	
RF OUTPUT	*						
f <sub>OUT</sub>	RF output frequency			12.5	2000	MHz	
P <sub>OUT</sub>	Single-ended output power	f <sub>OUT</sub> = 2 GHz		5		dBm	
		f <sub>OUT</sub> = 800 MHz		-33.5			
H2 <sub>OUT</sub>	Second harmonic	f <sub>OUT</sub> = 400 MHz	OUTx_PWR	-43		dBc	
		f <sub>OUT</sub> = 800 MHz	_ = 15	-10.5			
H3 <sub>OUT</sub>	Third harmonic	f <sub>OUT</sub> = 400 GHz	1	-10			
t <sub>skew</sub> CH	Channel to channel skew	f <sub>OUT</sub> = 2 GHz		14		ps	

<sup>(8)</sup> See VCO Calibration for details.

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<sup>(9)</sup> Not tested in production. Ensured by characterization. Allowable temperature drift refers to programming the device at an initial temperature and allowing this temperature to drift WITHOUT reprogramming the device, and still have the device stay at lock. This change could be up or down in temperature and the specification does not apply to temperatures that go outside the recommended operating temperatures of the device.



**Electrical Characteristics (continued)** 

 $3.0 \text{ V} \le \text{V}_{\text{CC}} \le 3.5 \text{ V}, -40^{\circ}\text{C} \le \text{T}_{\text{A}} \le 85^{\circ}\text{C}.$  Typical values are at  $\text{V}_{\text{CC}} = 3.3 \text{ V}, 25^{\circ}\text{C}$  (unless otherwise noted).

	PARAMETER	TEST CONDITION	S	MIN	TYP	MAX	UNIT
PHASE SYN	CHRONIZATION					•	
f <sub>OSCin</sub> SYNC	OSCin input frequency with	Category 3		5		100	NAL I-
	SYNC	Categories 1 and 2		5		200	MHz
t <sub>skew</sub> SYNC	OSCin to RFout skew	After phase synchronization; f <sub>OSCin</sub> SYNC = f <sub>OUT</sub> = 100 MHz			2		ns
DIGITAL INT	ERFACE						
V <sub>IH</sub>	High-level input voltage			1.4		$V_{CC}$	V
V <sub>IL</sub>	Low-level input voltage					0.4	V
I <sub>IH</sub>	High-level input current			-25		25	
I <sub>IL</sub>	Low-level input current			-25		25	μΑ
V <sub>OH</sub>	High-level output voltage	Load current = -5 mA	MILIVantaia	V <sub>CC</sub> - 0.5			W
V <sub>OL</sub>	Low-level output voltage	Load current = 5 mA	MUXout pin			0.5	V

#### 6.6 Timing Requirements

 $3.0 \text{ V} \le \text{V}_{CC} \le 3.5 \text{ V}$ ,  $-40^{\circ}\text{C} \le \text{T}_{A} \le 85^{\circ}\text{C}$ . Typical values are at  $\text{V}_{CC} = 3.3 \text{ V}$ ,  $25^{\circ}\text{C}$  (unless otherwise noted).

			MIN NOM	MAX	UNIT
SERIAI	L INTERFACE WRITE TIMING	1			
f <sub>SCK</sub>	SCK frequency	1 / (t <sub>CWL</sub> +t <sub>CWH</sub> )		75	MHz
t <sub>ES</sub>	SCK to CSB low time		5		ns
t <sub>CS</sub>	SDI to SCK setup time		2		ns
t <sub>CH</sub>	SDI to SCK hold time		2		ns
t <sub>CWH</sub>	SCK pulse width high	Figure 1	5		ns
t <sub>CWL</sub>	SCK pulse width low		5		ns
t <sub>CES</sub>	CSB to SCK setup time		5		ns
t <sub>EWH</sub>	CSB pulse width high		2		ns
SERIAI	L INTERFACE READ TIMING				
f <sub>SCK</sub>	SCK frequency	1 / (t <sub>CWL</sub> +t <sub>CWH</sub> )		50	MHz
t <sub>ES</sub>	SCK to CSB low time		10		ns
t <sub>CS</sub>	SDI to SCK setup time		10		ns
t <sub>CH</sub>	SDI to SCK hold time		10		ns
t <sub>CWH</sub>	SCK pulse width high	Figure 1	10		ns
t <sub>CWL</sub>	SCK pulse width low		10		ns
t <sub>CES</sub>	CSB to SCK setup time		10		ns
t <sub>EWH</sub>	CSB pulse width high		10		ns
SYNC 7	TIMING	·	<u> </u>		
t <sub>CS</sub>	Pin to OSCin setup time	Figure 2	2.5		ns
t <sub>CH</sub>	Pin to OSCin hold time	Figure 2	2		ns

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## 6.7 Timing Diagrams

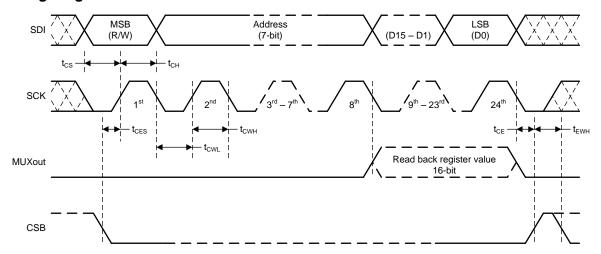


Figure 1. Serial Interface Timing Diagram

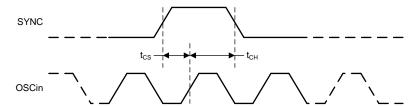
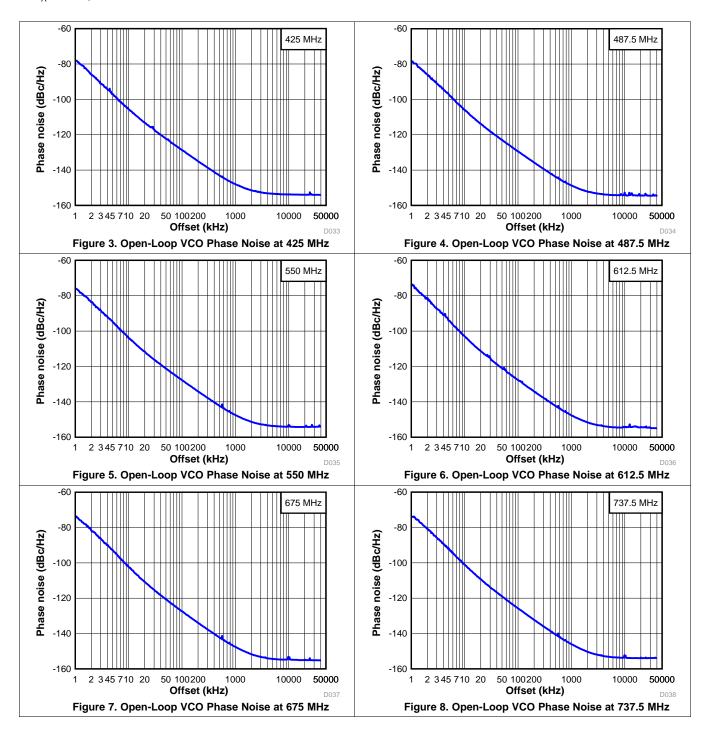


Figure 2. SYNC Timing Diagram

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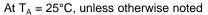
#### 6.8 Typical Characteristics

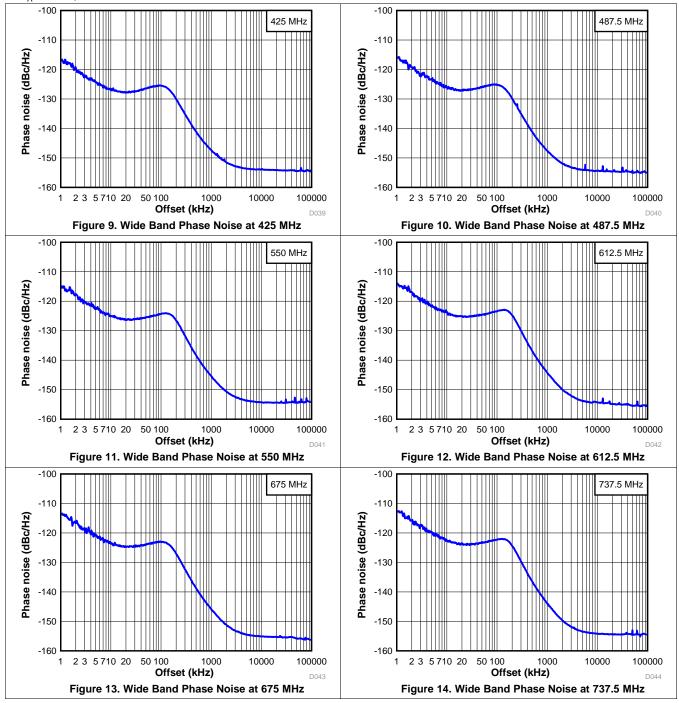
At  $T_A = 25$ °C, unless otherwise noted



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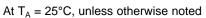
#### **Typical Characteristics (continued)**

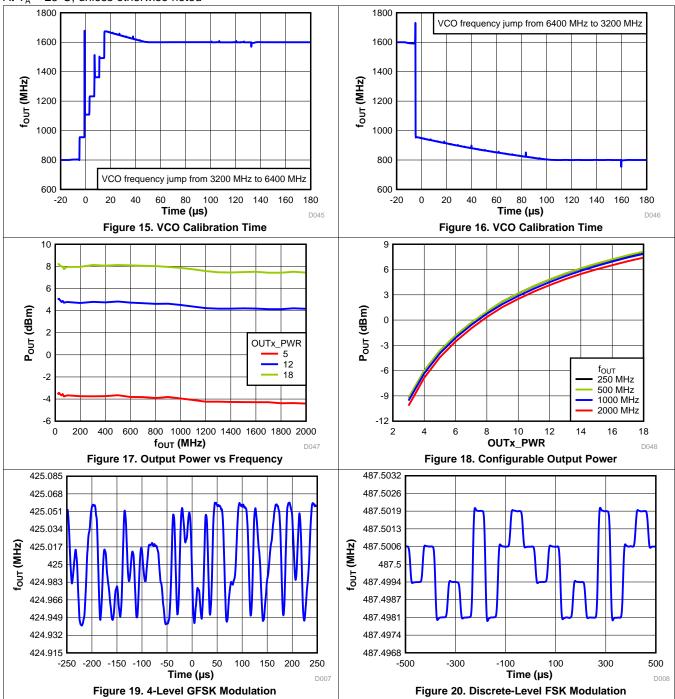






## **Typical Characteristics (continued)**





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#### 7 Detailed Description

#### 7.1 Overview

The LMX2572LP is a low-power, high-performance, wideband frequency synthesizer with integrated VCO and output divider. The VCO operates from 3.2 to 6.4 GHz, and this can be combined with the output divider to produce any frequency in the range of 12.5 MHz to 2 GHz. Within the input path, there are two dividers and a multiplier for flexible frequency planning. The multiplier can also move the frequencies away from the integer boundary to allow spur reduction.

The PLL is a fractional-N PLL with a programmable delta-sigma modulator up to 4<sup>th</sup> order. The fractional denominator is a programmable 32-bit long that can supply fine frequency steps easily below the 1-Hz resolution. The denominator can also be used to do exact fractions like 1/3, 7/1000, and many others.

For applications where deterministic or adjustable phase is desired, the SYNC pin can be used to get the phase relationship between the OSCin and RFout pins deterministic. Once this is done, the phase can be adjusted in very fine steps of the VCO period divided by the fractional denominator.

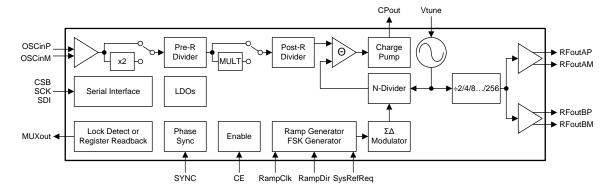
The ultra-fast VCO calibration is ideal for applications where the frequency must be swept or abruptly changed. The frequency can be manually programmed, or the device can be set up to do ramps and chirps.

The FSK generator can support FSK generation in discrete 2-, 4-, or 8-level FSK. It can also support an arbitrary level FSK.

The LMX2572LP device requires only a single 3.3-V power supply and uses very low current. The internal power supplies are provided by integrated LDOs, eliminating the need for high performance external LDOs.

Digital logic interface is compatible with 1.8-V input. The user can program the device through the serial interface. The device can be powered down through register programming or by toggling the Chip Enable (CE) pin.

#### 7.2 Functional Block Diagram



#### 7.3 Feature Description

#### 7.3.1 Reference Oscillator Input

The OSCin pins are used as a frequency reference input to the device. The input is high impedance and requires AC-coupling capacitors at the pin. The OSCin pins can be driven single-ended with a CMOS clock, XO, or single-ended differential clock. Differential clock input is also supported, which makes the device easier to interface with high-performance system clock devices such as TI's LMK series clock devices. As the OSCin signal is used as a clock for the VCO calibration, a proper reference signal must be applied at the OSCin pin at the time of programming FCAL\_EN.

#### 7.3.2 Reference Path

The reference path consists of an OSCin doubler (OSC\_2X), Pre-R divider (PLL\_R\_PRE), Multiplier (MULT), and a Post-R divider (PLL\_R).



#### **Feature Description (continued)**

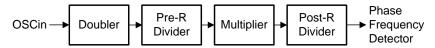


Figure 21. Reference Path

The Doubler allows one to double the input reference frequency up to 250 MHz. The Doubler adds minimal noise and is useful for raising the phase detector frequency for better phase noise. The Doubler can also be used to avoid spurs. The Doubler uses both the rising and falling edges of the input signal, so the input signal must have 50% duty cycle if the Doubler is enabled. Note that the Multiplier cannot be used if the Doubler is engaged.

The Pre-R divider can help reduce input frequency so that the Multiplier can be used and the maximum 200-MHz input frequency limitation of the Post-R divider can be met.

The Multiplier multiplies the frequency up under the allowable multiplications of 3, 4, 5, 6, and 7. In combination with the Pre-R and Post-R dividers, the Multiplier offers the flexibility to shift the phase detector frequency away from frequencies that may create integer boundary spurs with the VCO and the output frequencies. Be aware that unlike the Doubler, the Multiplier degrades the PLL figure of merit. This degradation would only matter, however, for a very clean reference oscillator input and if the loop bandwidth was wide. The user should not use the Doubler while using the Multiplier. The Multiplier is bypassed if its value is set to 1.

The Post-R divider can be used to further divide down the frequency to the phase detector frequency. When it is used (PLL\_R > 1), the input frequency to this divider is limited to 200 MHz.

Use Equation 1 to calculate the phase detector frequency, 
$$f_{PD}$$
.  
 $f_{PD} = f_{OSCin} \times OSC_2X \times MULT / (PLL_R_PRE \times PLL_R)$  (1)

Table 1 summarizes the usage boundaries of these functional blocks in the reference path.

PARAMETER	VALUE	FREQ	PUT JENCY Hz)	FREQ	PUT JENCY Hz)	NOTES
		MIN	MAX	MIN	MAX	
OSCin	N/A	5	250			
Doubler	0 (Bypassed), 1 (x2)	5	125	10	250	When OSC_2X = 1, Multiplier cannot be used at the same time.
Pre-R divider	1 (Bypassed), 2, 3,, 254, 255	5	200	0.25	200	Keep it equals 1 unless when necessary.
Multiplier	1 (Bypassed), 3, 4, 5, 6, 7	10	40	60	150	When the output frequency is greater than 100MHz, set MULT_HI = 1.
Post-R divider	1 (Bypass), 2, 3,, 254, 255	5	200	0.25	200	

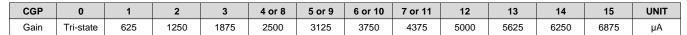
**Table 1. Reference Path Boundaries** 

#### 7.3.3 PLL Phase Detector and Charge Pump

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The phase detector compares the outputs of the Post-R divider and N divider and generates a correction current corresponding to the phase error until the two signals are aligned in phase. This charge-pump current is software programmable to many different levels, allowing modification of the closed-loop bandwidth of the PLL.

Table 2. Charge Pump Gain



## TEXAS INSTRUMENTS

#### 7.3.4 PLL N Divider and Fractional Circuitry

The N divider includes fractional compensation and can achieve any fractional denominator (PLL\_DEN) from 1 to  $(2^{32}-1)$ . The integer portion of N (PLL\_N) is the whole part of the N divider value, and the fractional portion,  $N_{frac} = PLL_NUM / PLL_DEN$ , is the remaining fraction. PLL\_N, PLL\_NUM and PLL\_DEN are software programmable. The higher the denominator, the finer the resolution step of the output. For example, even when using  $f_{PD} = 200$  MHz, the output can increment in steps of 200 MHz /  $(2^{32}-1) = 0.0466$  Hz. Equation 2 shows the relationship between the phase detector and VCO frequencies. Note that in SYNC mode, there is an extra divider that is not shown in Equation 2.

$$f_{VCO} = f_{PD} \times [PLL_N + (PLL_NUM / PLL_DEN)]$$
 (2)

The multi-stage noise-shaping (MASH) sigma-delta modulator that controls the fractional division is also programmable from integer mode to fourth order. All of these settings work for integer channel where PLL\_NUM = 0. To make the fractional spurs consistent, the modulator is reset any time that the R0 register is programmed.

The N divider has minimum value restrictions based on the modulator order. Furthermore, the PFD\_DLY\_SEL bit must be programmed in accordance to Table 3.

vco					MA	ASH ORDER				
FREQUENCY		INTEGER	FIE	RST ORDER	OND ORDER	TH	IRD ORDER	FOL	IRTH ORDER	
(GHz)	N	PFD_DLY_SEL	N	PFD_DLY_SEL	N	PFD_DLY_SEL	N	PFD_DLY_SEL	N	PFD_DLY_SEL
f <sub>VCO</sub> < 4	20	0	25 1		26	1	32	2	44	4
$4 \le f_{VCO} < 4.9$	24	1	29	2	30	2	32	2	44	4
4.9 ≤ f <sub>VCO</sub> ≤ 6.4	24	1	29	2	30	2	36	3	48	5

**Table 3. Minimum N Divider Restrictions** 

#### 7.3.5 Voltage-Controlled Oscillator

The LMX2572LP includes a fully integrated VCO. The VCO generates a frequency which varies with the tuning voltage from the loop filter. The entire VCO frequency range, 3.2 to 6.4 GHz, covers an octave that allows the channel divider to take care of frequencies below the lower bound.

To reduce the VCO tuning gain, thus improving the VCO phase noise performance, the VCO frequency range is divided into 6 different frequency bands. This creates the need for frequency calibration to determine the correct frequency band given in a desired output frequency. The VCO is also calibrated for amplitude to optimize phase noise. These calibration routines are activated any time that the R0 register is programmed with the FCAL\_EN bit equals one. It is important that a valid OSCin signal must present before VCO calibration begins. This device will support a full sweep of the valid temperature range of 125°C (–40°C to 85°C) without having to re-calibrate the VCO. This is important for continuous operation of the synthesizer under the most extreme temperature variation.

#### 7.3.6 Channel Divider

To go below the VCO lower bound of 3.2 GHz, the channel divider can be used. The channel divider consists of several segments, and the total division value is equal to the multiplication of them. Therefore, not all values are valid.

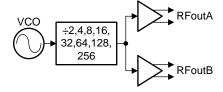


Figure 22. Channel Divider

#### 7.3.7 Output Buffer

The output buffers are differential push-pull type buffers, thus no external pullup to  $V_{CC}$  is required. The output impedance of the buffer is very small, and as such, the buffer can be AC-coupled to drive a  $50-\Omega$  load. Output power of the buffer can be programed to various levels. The buffer can be disabled while still keeping the PLL in lock.



#### 7.3.8 Lock Detect

The MUXout pin can be configured to output a signal that gives an indication for the PLL being locked. If the MUXout pin is configured as a lock detect output (MUXOUT\_LD\_SEL = 1), the MUXout pin output is a logic HIGH voltage when the device is locked. When the device is unlocked, the MUXout pin output is a logic LOW voltage.

There are options to select the definition of PLL being locked. If LD TYPE = 0, lock detect asserts a HIGH output after the VCO has finished calibration and the LD DLY timeout counter is finished. If LD TYPE = 1, in addition to the VCO calibration and counter check, lock detect will assert a HIGH output if the VCO tuning voltage is also within an acceptable limits.

#### 7.3.9 Register Readback

The MUXout pin can also be configured to read back useful information from the device. Common uses for readback are:

- Read back registers to ensure that they have been programmed to the correct value. LMX2572LP allows any of its registers to be read back.
- Read back the lock detect status to determine if the PLL is in lock.
- Read back VCO calibration information so that it can be used to improve the lock time.

#### 7.3.10 Powerdown

The user can use the CE pin or the POWERDOWN bit to power the LMX2572LP up or down. All registers are preserved in memory while the device is powered down.

The wake-up time for the device to come out of the powered state is adjustable. See Power-Up, Wake-Up Time for details.

#### 7.3.11 Phase Synchronization

The SYNC pin allows the user to synchronize the LMX2572LP such that the delay from the rising edge of th OSCin signal to the RF output signal is deterministic. Phase synchronization is especially useful if there are multiple LMX2572LP devices in a system and it is desirable to have all the RF outputs aligned in phase.

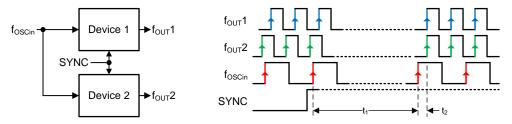


Figure 23. Phase Synchronization

Initially, the devices are locked to the input but are not synchronized. The user sends a synchronization pulse that is re-clocked to the next rising edge of the OSCin pulse. After a given time, t<sub>1</sub>, the devices are synchronized. This time is dominated by the sum of the VCO calibration time, the analog settling time of the PLL loop, and the MASH RST COUNT, if used in fractional mode. After synchronization, both devices will have a deterministic delay of t2, related to OSCin.

#### 7.3.12 Phase Adjustment

The LMX2572LP can use the sigma-delta modulator to adjust the output signal phase with respect to the input reference. The phase shift every time you write the value of MASH\_SEED is Equation 3:

Phase shift in degree = 360° x (MASH\_SEED / PLL\_DEN) x (P / CHDIV)

where

 P = 2 when VCO\_PHASE\_SYNC\_EN = 1, else P = 1 (3)

TEXAS INSTRUMENTS

For example, if

- MASH\_SEED = 800
- PLL DEN = 1000
- CHDIV = 32
- VCO\_PHASE\_SYNC\_EN = 0

Phase shift =  $360^{\circ} \times (800 / 1000) \times (1 / 32) = 9^{\circ}$ . If we write 800 to MASH\_SEED 40 times, then we will shift the phase by  $360^{\circ}$ .

There are a couple of restrictions when using phase adjustment:

- Phase adjustment does not work with MASH\_ORDER equals 0 (Integer mode) or 1 (First order).
- Phase adjustment is possible with integer channels (PLL\_NUM = 0) as long as MASH\_ORDER is greater than 1.
- PLL DEN must be greater than PLL NUM + MASH SEED.

#### 7.3.13 Ramping Function

The LMX2572LP supports the ability to make frequency ramping waveforms using manual mode or automatic mode.

In manual ramping mode, the user defines a step and uses the RampClk and RampDir pins to create the ramp. The output frequency jumps from one frequency to another frequency on each ramp.

In automatic ramping mode, the user sets up the ramp with up to two linear segments in advance and the device automatically creates this ramp. The output waveform is a continuous frequency sweep between the start and end frequencies. If the frequency ramping range is small (approximately 10 MHz), no VCO calibration break is necessary in the middle of the ramp.

When using ramp, the following must be set accordingly:

- Phase detector frequency must be between f<sub>OSCin</sub> / 2<sup>CAL\_CLK\_DIV</sup> and 125 MHz.
- OUT\_FORCE = 1 to force the RF outputs not to be automatically muted during VCO calibration.
- LD DLY = 0 to avoid interfering with VCO calibration.
- PLL DEN =  $2^{32}$  1. The actual denominator value being used in ramping mode is  $2^{24}$ .

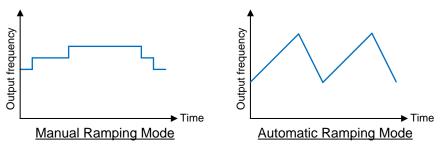


Figure 24. Ramping Modes

#### 7.3.14 FSK Modulation

Direct digital FSK modulation is supported in LMX2572LP. FSK modulation is achieved by changing the output frequency by changing the N divider value. The LMX2572LP supports three different types of FSK operation.

- 1. FSK SPI mode. This mode supports discrete 2-, 4- and 8-level FSK modulation. There are eight dedicated registers used to pre-store the desired FSK frequency deviations. Program FSK\_SPI\_DEV\_SEL to select one of the FSK deviations at a time.
- 2. FSK SPI FAST mode. In this mode, instead of selecting one of the pre-stored FSK deviations, change the FSK deviation directly by writing to FSK\_SPI\_FAST\_DEV. As a result, this mode supports arbitrary-level FSK, which is useful to construct pulse-shaping or analog-FM modulation.
- 3. FSK I2S mode. This mode is similar to the FSK SPI FAST mode, but the programming format is an I2S format on dedicated pins instead of SPI. The benefit of using I2S is that this interface could be shared and synchronous to other digital audio interfaces. In this mode, only the 16 bits of the DATA field are required to program. The data is transmitted on the high or low side of the frame sync (programmable in register R114,



FSK I2S FS POL). The unused side of the frame sync needs to be at least one clock cycle. In other words, 17 (16 + 1) CLK cycles are required at a minimum for one I2S frame. Maximum I2S clock rate is 75 MHz. Timing diagram is shown in Figure 26 while the timing specification is same as SPI write timing as shown in the *Timing Requirements* section.

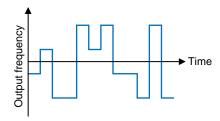


Figure 25. FSK Modulation

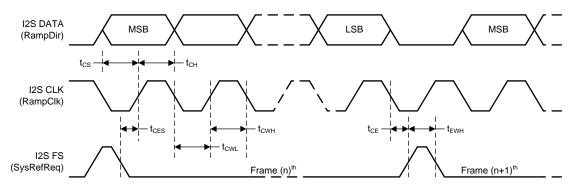


Figure 26. FSK I2S Timing Diagram

#### 7.4 Device Functional Modes

Table 4 lists the device functional modes of the LMX2572LP.

**DESCRIPTION** The device is used as a high frequency signal source without any addition features. Generates discrete-level FSK or arbitrary-level pulse-shaped FSK modulation

**Table 4. Device Functional Modes** 

This mode is used to ensure deterministic phase between OSCin and RFout.

Automatic frequency sweeping without the need of continuous SPI programming.

### 7.5 Programming

**MODE** 

Normal operation mode

FSK mode

SYNC mode

Ramping mode

The LMX2572LP is programmed using several 24-bit shift registers. The shift register consists of a data field, an address field, and a R/W bit. The MSB is the R/W bit. 0 means register write while 1 means register read. The following seven bits, ADDR[6:0], form the address field which is used to decode the internal register address. The remaining 16 bits form the data field DATA[15:0]. Serial data is shifted MSB first into the shift register. See Figure 1 for timing diagram details.

#### To write registers:

- The R/W bit must be set to 0.
- The data on SDI pin is clocked into the shift register upon the rising edge of the clocks on SCK pin. On the rising edge of the 24<sup>th</sup> clock cycle, the data is transferred from the data field into the selected register bank.
- The CSB pin may be held high after programming, which causes the LMX2572LP to ignore clock pulses.
- If the SCK and SDI lines are toggled while the VCO is in lock, as is sometimes the case when these lines are shared between devices, the phase noise may be degraded during the time of this programming.

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#### TEXAS INSTRUMENTS

#### **Programming (continued)**

To read back registers:

- The R/W bit must be set to 1.
- The data field contents on the SDI line are ignored.
- The read back data on MUXout pin is clocked out starting from the falling edge of the 8<sup>th</sup> clock cycle.

#### 7.5.1 Recommended Initial Power-On Programming

#### 7.5.1.1 Programming Sequence

When the device is first powered up, it must be initialized, and the ordering of this programming is important. The sequence is listed below. After this sequence is completed, the device should be running and locked to the proper frequency.

- 1. Apply power to the device and ensure all the supply pins are at the proper levels.
- 2. If CE is low, pull it high.
- 3. Wait 500 µs for the internal LDOs to become stable.
- 4. Ensure that a valid reference clock is applied to the OSCin pins.
- 5. Program register R0 with RESET = 1. This will ensure all the registers are reset to their default values. This bit is self-clearing.
- 6. Program in sequence registers R125, R124, R123, ..., R1 and then R0.

#### 7.5.1.2 Programming Register

There are altogether 126 programmable registers. However, not every register is required to be programmed at initial power-on.

For example, most of the registers have fixed field value which is also equal to their silicon default value. After programming R0 with RESET = 1, these register fields have returned to their silicon default values. As such, it is not necessary to program these registers again. Similarly, for those registers having configurable fields, if the desired field values are equal to the silicon default values, again it is not necessary to program these registers again after programming R0 with RESET = 1.

In Table 5, Depends means it is up to the user's decision of whether programming the register or not based upon the application need.

**Table 5. Suggested Register Programming** 

REGISTER	PROGRAM										
0	Yes	21	No	42	Yes	63	No	84	Depends	105	Depends
1	Depends	22	No	43	Yes	64	No	85	Depends	106	Depends
2	No	23	No	44	Depends	65	No	86	Depends	107	No
3	No	24	No	45	Depends	66	No	87	No	108	No
4	No	25	No	46	No	67	No	88	No	109	No
5	Depends	26	No	47	No	68	No	89	No	110	No
6	Depends	27	No	48	No	69	Depends	90	No	111	No
7	Depends	28	No	49	No	70	Depends	91	No	112	No
8	Depends	29	Yes	50	No	71	Yes	92	No	113	No
9	Depends	30	Yes	51	No	72	No	93	No	114	Depends
10	Depends	31	No	52	Yes	73	No	94	No	115	Depends
11	Depends	32	No	53	No	74	No	95	No	116	Depends
12	Depends	33	No	54	No	75	Depends	96	Depends	117	Depends
13	No	34	Depends	55	No	76	No	97	Depends	118	Depends
14	Depends	35	No	56	No	77	No	98	Depends	119	Depends
15	No	36	Yes	57	Yes	78	Yes	99	Depends	120	Depends
16	Depends	37	Yes	58	Depends	79	Depends	100	Depends	121	Depends
17	Depends	38	Yes	59	Depends	80	Depends	101	Depends	122	Depends
18	No	39	Yes	60	Depends	81	Depends	102	Depends	123	Depends
19	Depends	40	Depends	61	No	82	Depends	103	Depends	124	Depends



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#### **Programming (continued)**

Table 5. Suggested Register Programming (continued)

REGISTER	PROGRAM										
20	Depends	41	Depends	62	Depends	83	Depends	104	Depends	125	No

#### 7.5.2 Recommended Sequence for Changing Frequencies

The recommended sequence for changing frequencies in different scenarios is as follows:

- 1. If the N divider is changing, program the relevant registers and then program R0 with FCAL\_EN = 1.
- 2. In FSK and Ramp mode, the fractional numerator is changing; program the relevant registers only.

#### 7.5.3 Double Buffering

Some register fields support double buffering. That is, the change to these fields would not be effective immediately. To latch the new values into the device requires programming R0 again with FCAL\_EN = 1. The following register fields support double buffering, see Table 69 for details.

- MASH order (MASH ORDER)
- Fractional numerator (PLL\_NUM)
- N divider (PLL\_N)
- Doubler (OSC\_2X); Pre-R divider (PLL\_R\_PRE); Multiplier (MULT); Post-R divider (PLL\_R)

#### For example,

- 1. Program PLL\_R and PLL\_N to new values. If double buffering for these fields is enabled, the PLL will remain unchanged.
- 2. Program R0 with FCAL\_EN = 1. The PLL will calibrate and lock using the new PLL\_R and PLL\_N values.

#### 7.5.4 Block Programming

In a register write sequence, instead of sending 24 bits (one W/R bit, seven address bits, and 16 data bits) of payload for each register (with Block Programming), only the first register write requires the W/R bit and the address bits. The succeeding registers require sending only the 16-bit of data. However, the succeeding registers must be in descending order. For example, if the first register is R20, then all 24 bits of payload must be sent for R20. The next register must be R19, but only the 16-bit data is required. The programming sequence is as follows:

- 1. Pull CSB pin LOW.
- 2. Write 0x14aaaa for R20.
- 3. Write 0xbbbb for R19, followed by 0xcccc for R18, and so on.
- 4. After the last register write is completed, pull CSB pin HIGH to finish Block Programming.

Since there is no CSB pulse between each register, the 16-bit of data field of each register can be sent immediately after the previous one.

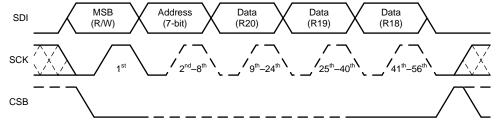
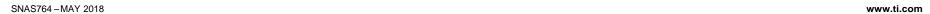


Figure 27. Block Programming Timing Example

Block Programming applies to both register write and read.



# TEXAS INSTRUMENTS

## 7.6 Register Maps

DEC								DATA[15	:0]								POR
REG.	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	POR
R0	RAMP_EN	VCO_PHASE_ SYNC_EN	1	0	ADD_HOLD	0	OUT_MUTE	FCAL_H	PFD_ADJ	FCAL_L	PFD_ADJ	1	FCAL_EN	MUXOUT_ LD_SEL	RESET	POWER DOWN	00221Ch
R1	0	0	0	0	1	0	0	0	0	0	0	0	1		CAL_CLK_D	IV	010808h
R2	0	0	0	0	0	1	0	1	0	0	0	0	0	0	0	0	020500h
R3	0	0	0	0	0	1	1	1	1	0	0	0	0	0	1	0	030782h
R4	0	0	0	0	1	0	1	0	0	1	0	0	0	0	1	1	040A43h
R5	0	0	1	IPBUF_ TYPE	IPBUF_ TERM	0	0	0	1	1	0	0	1	0	0	0	0530C8h
R6		LC	OO_DLY			0	0	0	0	0	0	0	0	0	1	0	06C802h
R7	0	OUT_ FORCE	0	0	0	0	0	0	1	0	1	1	0	0	1	0	0700B2h
R8	0	VCO_ DACISET_ FORCE	1	0	VCO_ CAPCTRL_ FORCE	0	0	0	0	0	0	0	0	0	0	0	082000h
R9	0	MULT_HI	0	OSC_2X	0	0	0	0	0	0	0	0	0	1	0	0	090004h
R10	0	0	0	1			MULT			1	1	1	1	0	0	0	0A10F8h
R11	1	0	1	1				PLL_	R				1	0	0	0	0BB018h
R12	0	1	0	1						PLL	_R_PRE						0C5001h
R13	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0D4000h
R14	0	0	0	1	1	0	0	0	0		(	CPG	<u>'</u>	0	0	0	0E1840h
R15	0	0	0	0	0	1	1	0	0	0	0	0	1	1	1	0	0F060Eh
R16	0	0	0	0	0	0	0					VCO_DA	CISET				100080h
R17	0	0	0	0	0	0	0					VCO_DACIS	ET_STRT				110096h
R18	0	0	0	0	0	0	0	0	0	1	1	0	0	1	0	0	120064h
R19	0	0	1	0	0	1	1	1				VC	O_CAPCTRL				1327B7h
R20	0	1		VCO_SE	L	VCO_SEL_ FORCE	0	0	0	1	0	0	1	0	0	0	143048h
R21	0	0	0	0	0	1	0	0	0	0	0	0	1	0	0	1	150409h
R22	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	160001h
R23	0	0	0	0	0	0	0	0	0	1	1	1	1	1	0	0	17007Ch
R24	0	0	0	0	0	1	1	1	0	0	0	1	1	0	1	0	18071Ah
R25	0	0	0	0	0	1	1	0	0	0	1	0	0	1	0	0	190624h
R26	0	0	0	0	1	0	0	0	0	0	0	0	1	0	0	0	1A0808h
R27	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	1B0002h
R28	0	0	0	0	0	1	0	0	1	0	0	0	1	0	0	0	1C0488h
R29	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1D18C6h
R30	0	0	0	0	1	1	0	0	1	0	1	0	0	1	1	0	1E18C6h
R31	1	1	0	0	0	0	1	1	1	1	1	0	0	1	1	0	1FC3E6h
R32	0	0	0	0	0	1	0	1	1	0	1	1	1	1	1	1	2005BFh
R33	0	0	0	1	1	1	1	0	0	0	0	0	0	0	0	1	211E01h
R34	0	0	0	0	0	0	0	0	0	0	0	1	0		PLL_N[18:10	6]	220010h

20





## **Register Maps (continued)**

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DEC								DATA[15	5:0]								DOC
REG.	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	POR
R35	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0	230004h
R36								PLL_N	I					-1			240028h
R37	MASH_ SEED_EN	0			PFD_	DLY_SEL			0	0	0	0	0	1	0	1	250205h
R38								PLL_DEN[3	31:16]					-1			26FFFFh
R39								PLL_DEN[	15:0]								27FFFFh
R40							ı	MASH_SEED	[31:16]								280000h
R41								MASH_SEEI	D[15:0]								290000h
R42								PLL_NUM[3	31:16]								2A0000h
R43								PLL_NUM[	15:0]								2B0000h
R44	0	0			OUT	A_PWR			OUTB_ PD	OUTA_ PD	MASH_ RESET_N	0	0		MASH_ORE	DER	2C08A2h
R45	1	1	0	0	0	1	1	0	0	0			OU	ITB_PWR			2DC608h
R46	0	0	0	0	0	1	1	1	1	1	1	1	0	0	0	0	2E07F0h
R47	0	0	0	0	0	0	1	1	0	0	0	0	0	0	0	0	2F0300h
R48	0	0	0	0	0	0	1	1	1	1	1	0	0	0	0	0	3003E0h
R49	0	1	0	0	0	0	0	1	1	0	0	0	0	0	0	0	314180h
R50	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	320080h
R51	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	330080h
R52	0	0	0	0	0	1	0	0	0	0	1	0	0	0	0	1	340420h
R53	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	350000h
R54	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	360000h
R55	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	370000h
R56	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	380000h
R57	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0	390000h
R58	INPIN_ IGNORE	INPIN_ HYST	INPIN	N_LVL		INPIN_FMT		0	0	0	0	0	0	0	0	1	3A8001h
R59	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	LD_TYPE	3B0001h
R60								LD_DL	Υ					-1			3C03E8h
R61	0	0	0	0	0	0	0	0	1	0	1	0	1	0	0	0	3D00A8h
R62	DBLBUF_ EN_5	DBLBUF_ EN_4	DBLBUF_ EN_3	DBLBUF_ EN_2	DBLBUF_ EN_1	DBLBUF_ EN_0	0	0	1	0	1	0	1	1	1	1	3E00AFh
R63	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	3F0000h
R64	0	0	0	1	0	0	1	1	1	0	0	0	1	0	0	0	401388h
R65	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	410000h
R66	0	0	0	0	0	0	0	1	1	1	1	1	0	1	0	0	4201F4h
R67	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	430000h
R68	0	0	0	0	0	0	1	1	1	1	1	0	1	0	0	0	4403E8h
R69					· L		MAS	H_RST_CO	UNT[31:16]					1		· ·	450000h
R70								SH_RST_CC									46C350h

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21



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## **Register Maps (continued)**

								DATA[15	:0]								
REG.	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	POR
R71	0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	1	470080h
R72	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	480001h
R73	0	0	0	0	0	0	0	0	0	0	1	1	1	1	1	1	49003Fh
R74	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	4A0000h
R75	0	0	0	0	1			CHDIV			0	0	0	0	0	0	4B0800h
R76	0	0	0	0	0	0	0	0	0	0	0	0	1	1	0	0	4C000Ch
R77	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	4D0000h
R78	0	0	0	0	RAMP_ THRESH[32]	0	QUICK_ RECAL_EN				VCO_CA	PCTRL_STRT				1	4E0064h
R79							R.A	AMP_THRES	H[31:16]								4F0000h
R80							R	AMP_THRES	SH[15:0]		_						500000h
R81	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	RAMP_LIMIT_ HIGH[32]	510000h
R82							RAN	MP_LIMIT_HI	GH[31:16]							·	520000h
R83							RA	MP_LIMIT_H	IGH[15:0]								530000h
R84	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	RAMP_LIMIT_ LOW[32]	540000h
R85							RAI	MP_LIMIT_LC	DW[31:16]								550000h
R86							RA	MP_LIMIT_L	OW[15:0]								560000h
R87	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	570000h
R88	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	580000h
R89	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	590000h
R90	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5A0000h
R91	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5B0000h
R92	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5C0000h
R93	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5D0000h
R94	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5E0000h
R95	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	5F0000h
R96	RAMP_ BURST_EN			1			RAMP_B	URST_COU	NT						0	0	600000h
R97	RAMP0_RST	0	0	0	0		RAMP_T	RIGB			RAME	P_TRIGA		0	RAMP	_BURST_TRIG	610000h
R98							RAMP0_INC[29								0	RAMP0_DLY	620000h
R99								RAMP0_INC									630000h
R100								RAMP0_L	.EN		1	1					640000h
R101	0	0	0	0	0	0	0	0	0	RAMP1_ DLY	RAMP1_ RST	RAMP0_ NEXT	0	0	RAMP	0_NEXT_TRIG	650000h
R102	0	0							RAMP1	_INC[29:16]							660000h
R103								RAMP1_INC									670000h
R104								RAMP1_L	.EN		1	Т	1	T	_		680000h
R105					RAMP_DLY_	CNT					RAMP_ MANUAL	RAMP1_ NEXT	0	0	RAMP	1_NEXT_TRIG	694440h

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## **Register Maps (continued)**

BEO								DATA[15	:0]								DOD.
REG.	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	POR
R106	0	0	0	0	0	0	0	0	0	0	0	RAMP_ TRIG_CAL	0	RAM	MP_SCALE_C	OUNT	6A0007h
R107	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	6B0000h
R108	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	6C0000h
R109	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	6D0000h
R110	0	0	0	0	0	rb_LD_	VTUNE	0		rb_VCO_SE	L	0	0	0	0	0	6E0000h
R111	0	0	0	0	0	0	0	0				rb_VC0	O_CAPCTRL				6F0000h
R112	0	0	0	0	0	0	0					rb_VCO_DA	CISET				700000h
R113	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	710000h
R114	0	1	1	1	1	FSK_EN	0	FSK_I2S_ FS_POL	FSK_I2S_ CLK_POL	FSK_SF	PI_LEVEL	FSI	K_SPI_DEV_	SEL	FSK_N	MODE_SEL	727800h
R115	0	0	0	0	0	0	0	0		F	SK_DEV_S	CALE		0	0	0	730000h
R116				•				FSK_DE	V0								740000h
R117								FSK_DE	V1								750000h
R118								FSK_DE	V2								760000h
R119								FSK_DE	V3								770000h
R120								FSK_DE	V4								780000h
R121		FSK_DEV5 790									790000h						
R122		FSK_DEV6 7AI									7A0000h						
R123	FSK_DEV7 7Bi								7B0000h								
R124							F	SK_SPI_FAS	ST_DEV								7C0000h
R125	0	0	0	0	1	0	0	0	0	0	1	0	0	0	0	0	7D0820h

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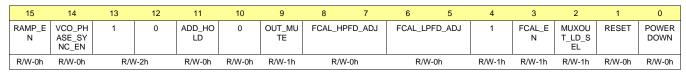
Table 6 lists the access codes for the LMX2572 registers.

#### **Table 6. Access Type Codes**

ACCESS TYPE	CODE	DESCRIPTION
Read Type		
R	R	Read
Write Type		
W	W	Write
Reset or Default	Value	
-n		Value after reset

#### 7.6.1 Register R0 (offset = 00h) [reset = 221Ch]

#### Figure 28. Register R0



### Table 7. Register R0 Field Descriptions

Bit	Field	Туре	Reset	Description
15	RAMP_EN	R/W	Oh	Enables frequency ramping. The action of programming register R0 with RAMP_EN = 1 starts the ramping. Be aware that this is in the same register as FCAL_EN, so toggling this bit also can active the ramping if RAMP_EN = 1. RAMP_EN applies to both automatic and manual ramping modes.  0: Normal operation 1: Starts frequency ramping
14	VCO_PHASE_SYNC_EN	R/W	0h	Enables phase sync mode. In this state, part of the channel divider is put in the feedback path to ensure deterministic phase. The action of toggling this bit from 0 to 1 also sends an asynchronous SYNC pulse.  0: Normal operation 1: Phase sync mode
13 - 12		R/W	2h	Program 2h to this field.
11	ADD_HOLD	R/W	0h	Freeze the register address in Block Programming. See Block Programming for details.
10		R/W	0h	Program 0h to this field.
9	OUT_MUTE	R/W	1h	Mutes RF outputs (RFoutA and RFoutB) when the VCO is calibrating. 0: Disabled 1: Muted
8 - 7	FCAL_HPFD_ADJ	R/W	Oh	Set this field in accordance to the phase detector frequency for optimal VCO calibration. 0: $f_{PD} \le 37.5$ MHz 1: 37.5 MHz $< f_{PD} \le 75$ MHz 2: 75 MHz $< f_{PD} \le 100$ MHz 3: $f_{PD} > 100$ MHz
6 - 5	FCAL_LPFD_ADJ	R/W	Oh	Set this field in accordance to the phase detector frequency for optimal VCO calibration. 0: $f_{PD} \ge 10$ MHz 1: 10 MHz > $f_{PD} \ge 5$ MHz 2: 5 MHz > $f_{PD} \ge 2.5$ MHz 3: $f_{PD} \le 2.5$ MHz
4		R/W	1h	Program 1h to this field.
3	FCAL_EN	R/W	1h	Enables and activates VCO frequency calibration. Writing register R0 with this bit set to a 1 enables and triggers the VCO frequency calibration. Writing 0 to this field is prohibited.  0: Invalid 1: Enabled

Product Folder Links: LMX2572LP



## Table 7. Register R0 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
2	MUXOUT_LD_SEL	R/W	1h	Selects the functionality of the MUXout pin. 0: Register readback 1: Lock detect
1	RESET	R/W	0h	Resets all registers to silicon default values. This bit is self-clearing. 0: Normal operation 1: Reset
0	POWERDOWN	R/W	0h	Powers down the device. 0: Normal operation 1: Power down

#### 7.6.2 Register R1 (offset = 01h) [reset = 0808h]

#### Figure 29. Register R1

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	1	0	0	0	0	0	0	0	1	С	AL_CLK_DIV	′
	R/W-101h													R/W-0h	

## **Table 8. Register R1 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 3		R/W	101h	Program 101h to this field.
2 - 0	CAL_CLK_DIV	R/W	Oh	Divides down the state machine clock during VCO calibration. Maximum state machine clock frequency is 200 MHz. State machine clock frequency = $f_{OSCin} / (2^{CAL\_CLK\_DIV})$ . 0: $f_{OSCin} \le 200$ MHz 1: 200 MHz $< f_{OSCin} \le 250$ MHz All other values are not used.

#### 7.6.3 Register R2 (offset = 02h) [reset = 0500h]

#### Figure 30. Register R2

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	0	1	0	0	0	0	0	0	0	0
							R/W-	-500h							

#### Table 9. Register R2 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	500h	Program 500h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.4 Register R3 (offset = 03h) [reset = 0782h]

#### Figure 31. Register R3

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	1	1	1	0	0	0	0	0	1	0
							R/W-	782h							

#### Table 10. Register R3 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	782h	Program 782h to this field.
				After programming R0 with RESET = 1, no need to program this register.

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#### 7.6.5 Register R4 (offset = 04h) [reset = 0A43h]

#### Figure 32. Register R4

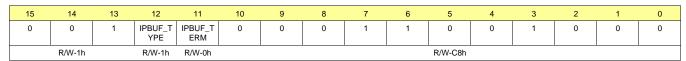
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	1	0	1	0	0	1	0	0	0	0	1	1
			•		•		R/W-	A43h		•					

#### Table 11. Register R4 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	A43h	Program A43h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.6 Register R5 (offset = 05h) [reset = 30C8h]

#### Figure 33. Register R5



#### Table 12. Register R5 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 13		R/W	1h	Program 1h to this field.
12	IPBUF_TYPE	R/W	1h	Selects OSCin input type. 0: Differential input 1: Single-ended input
11	IPBUF_TERM	R/W	0h	Enables internal 50-Ω terminations on both OSCin and OSCin* pins. This function is valid even if OSCin input is configured as single-ended input.  0: Normal operation  1: OSCin and OSCin* pins are internally 50-Ω terminated
10 - 0		R/W	C8h	Program C8h to this field.

#### 7.6.7 Register R6 (offset = 06h) [reset = C802h]

## Figure 34. Register R6

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
		LDO_DLY			0	0	0	0	0	0	0	0	0	1	0
		R/W-19h								R/W-2h					

#### Table 13. Register R6 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 11	LDO_DLY	R/W	-	LDO start up delay. Delay duration is a function of state machine clock. See Power-Up, Wake-Up Time for details.
10 - 0		R/W	2h	Program 2h to this field.

## 7.6.8 Register R7 (offset = 07h) [reset = 00B2h]

### Figure 35. Register R7

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	OUT_FO RCE	0	0	0	0	0	0	1	0	1	1	0	0	1	0
R/W-0h	R/W-0h							R/W	-B2h						

Product Folder Links: LMX2572LP

26



## Table 14. Register R7 Field Descriptions

Bit	Field	Туре	Reset	Description
15		R/W	0h	Program 0h to this field.
14	OUT_FORCE	R/W	0h	Forces the RF outputs not to be automatically muted during VCO calibration. This bit should be enabled during frequency ramping.  0: Mute setting depends on OUT_MUTE  1: No mute during VCO calibration
13 - 0		R/W	B2h	Program B2h to this field.

#### 7.6.9 Register R8 (offset = 08h) [reset = 2000h]

#### Figure 36. Register R8

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	VCO_DA CISET_F ORCE	1	0	VCO_CA PCTRL_ FORCE	0	0	0	0	0	0	0	0	0	0	0
R/W-0h	R/W-0h	R/V	V-2h	R/W-0h						R/W-0h					

#### **Table 15. Register R8 Field Descriptions**

Bit	Field	Туре	Reset	Description									
15		R/W	0h	Program 0h to this field.									
14	VCO_DACISET_FORCE	R/W	0h	Forces VCO_DACISET value. Useful for fully-assisted VCO calibration and debugging purposes.  0: Normal operation  1: Use VCO_DACISET value instead of the value obtained from VCO calibration									
13 - 12		R/W	2h	Program 2h to this field.									
11	VCO_CAPCTRL_FORCE	R/W	0h	Forces VCO_CAPCTRL value. Useful for fully-assisted VCO calibration and debugging purposes.  0: Normal operation  1: Use VCO_CAPCTRL value instead of the value obtained from VCO calibration									
10 - 0		R/W	0h	Program 0h to this field.									

## 7.6.10 Register R9 (offset = 09h) [reset = 0004h]

#### Figure 37. Register R9

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	MULT_H I	0	OSC_2X	0	0	0	0	0	0	0	0	0	1	0	0
R/W-0h	R/W-0h	R/W-0h	R/W-0h	R/W-4h											

#### **Table 16. Register R9 Field Descriptions**

Bit	Field	Туре	Reset	Description
15		R/W	0h	Program 0h to this field.
14	MULT_HI	R/W	0h	Sets this bit to 1 if the output frequency of the Multiplier is greater than 100 MHz.  0: Multiplier output ≤ 100 MHz  1: Multiplier output > 100 MHz
13		R/W	0h	Program 0h to this field.
12	OSC_2X	R/W	0h	Enables reference path Doubler. 0: Disabled 1: Enabled
11 - 0		R/W	4h	Program 4h to this field.



#### 7.6.11 Register R10 (offset = 0Ah) [reset = 10F8h]

## Figure 38. Register R10

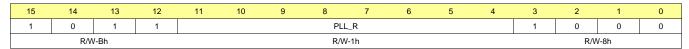
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
0	0	0	1			MULT			1 1 1 1 0 0						0	
	R/V	V-1h			R/W-1h					R/W-78h						

#### Table 17. Register R10 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 12		R/W	1h	Program 1h to this field.
11 - 7	MULT	R/W	1h	Reference path frequency Multiplier. Input frequency to the Multiplier: 10 to 40 MHz. Multiplier output frequency: 60 to 150 MHz. 0: Not used 1: Bypassed 2: Not recommended. Use OSC_2X instead of MULT 3: 3X 7: 7X 8 - 31: Not recommended
6 - 0		R/W	78h	Program 78h to this field.

#### 7.6.12 Register R11 (offset = 0Bh) [reset = B018h]

#### Figure 39. Register R11

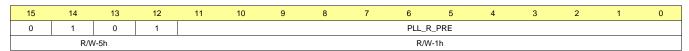


#### Table 18. Register R11 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 12		R/W	Bh	Program Bh to this field.
11 - 4	PLL_R	R/W	1h	Reference path Post-R divider. It is the divider after the frequency Multiplier.
3 - 0		R/W	8h	Program 8h to this field.

#### 7.6.13 Register R12 (offset = 0Ch) [reset = 5001h]

#### Figure 40. Register R12



#### **Table 19. Register R12 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 12		R/W	5h	Program 5h to this field.
11 - 0	PLL_R_PRE	R/W	1h	Reference path Pre-R divider. It is the divider before the frequency Multiplier.

#### 7.6.14 Register R13 (offset = 0Dh) [reset = 4000h]

#### Figure 41. Register R13

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-4000h														



## Table 20. Register R13 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	4000h	Program 4000h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.15 Register R14 (offset = 0Eh) [reset = 1840h]

#### Figure 42. Register R14

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	1	1	0	0	0	0		CI	PG	0	0	0	
	R/W-30h									R/V	V-8h			R/W-0h	

#### Table 21. Register R14 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 7		R/W	30h	Program 30h to this field.
6 - 3	CPG	R/W	8h	Effective charge pump gain. This is the sum of the up and down currents. Each increment represents 625 $\mu$ A. 0: Tri-state 1: 625 $\mu$ A 2: 1250 $\mu$ A 3: 1875 $\mu$ A 15: 6875 $\mu$ A
2 - 0		R/W	0h	Program 0h to this field.

#### 7.6.16 Register R15 (offset = 0Fh) [reset = 060Eh]

#### Figure 43. Register R15

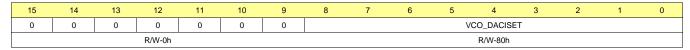
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	1	0	0	0	0	0	1	1	1	0
	R/W-60Eh														

#### Table 22. Register R15 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	60Eh	Program 60Eh to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.17 Register R16 (offset = 10h) [reset = 0080h]

#### Figure 44. Register R16



#### Table 23. Register R16 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 9		R/W	0h	Program 0h to this field.
8 - 0	VCO_DACISET	R/W	80h	Programmable current setting for the VCO that is applied when VCO_DACISET_FORCE = 1. Useful for fully-assisted VCO calibration.

#### 7.6.18 Register R17 (offset = 11h) [reset = 0096h]

#### Figure 45. Register R17

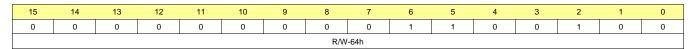
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	VCO_DACISET_STRT								
R/W-0h											R/W-96h				

#### Table 24. Register R17 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 9		R/W	0h	Program 0h to this field.
8 - 0	VCO_DACISET_STRT	R/W	96h	Starting calibration value for VCO_DACISET.

#### 7.6.19 Register R18 (offset = 12h) [reset = 0064h]

#### Figure 46. Register R18



#### Table 25. Register R18 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	64h	Program 64h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.20 Register R19 (offset = 13h) [reset = 27B7h]

#### Figure 47. Register R19

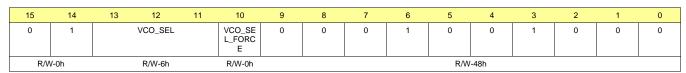
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	1	0	0	1	1	1	VCO_CAPCTRL							
	R/W-27h										R/W-	B7h			

#### Table 26. Register R19 Field Descriptions

	Bit	Field	Туре	Reset	Description
1	5 - 8		R/W	27h	Program 27h to this field.
7	7 - 0	VCO_CAPCTRL	R/W	B7h	Programmable band within VCO core that applies when VCO_CAPCTRL_FORCE = 1. Valid values are 183 to 0, where the higher number is a lower frequency.

#### 7.6.21 Register R20 (offset = 14h) [reset = 3048h]

#### Figure 48. Register R20



#### Table 27. Register R20 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 14		R/W	0h	Program 1h to this field.
13 - 11	VCO_SEL	R/W	6h	User specified start VCO for calibration. This sets the VCO that is used when VCO_SEL_STRT_EN = 1 or VCO_SEL_FORCE = 1.  1: VCO1  2: VCO2  6: VCO6 All other values are not used.



www.ti.com SNAS764 – MAY 2018

#### Table 27. Register R20 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
10	VCO_SEL_FORCE	R/W	0h	Forces the VCO to use the core specified by VCO_SEL. 0: Disabled 1: Enabled
9 - 0		R/W	48h	Program 48h to this field.

#### 7.6.22 Register R21 (offset = 15h) [reset = 0409h]

#### Figure 49. Register R21

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	0	0	0	0	0	0	1	0	0	1
	R/W-409h														

#### Table 28. Register R21 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	409h	Program 409h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.23 Register R22 (offset = 16h) [reset = 0001h]

#### Figure 50. Register R22

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1
							R/V	/-1h							

#### Table 29. Register R22 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	1h	Program 1h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.24 Register R23 (offset = 17h) [reset = 007Ch]

#### Figure 51. Register R23

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	1	1	1	1	1	0	0
	R/W-7Ch														

#### **Table 30. Register R23 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 0		R/W	7Ch	Program 7Ch to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.25 Register R24 (offset = 18h) [reset = 071Ah]

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#### Figure 52. Register R24

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	1	1	0	0	0	1	1	0	1	0
	R/W-71Ah														

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Bit	Field	Туре	Reset	Description
15 - 0		R/W	71Ah	Program 71Ah to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.26 Register R25 (offset = 19h) [reset = 0624h]

#### Figure 53. Register R25

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	1	0	0	0	1	0	0	1	0	0
	R/W-624h														

#### Table 32. Register R25 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	624h	Program 624h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.27 Register R26 (offset = 1Ah) [reset = 0808h]

#### Figure 54. Register R26

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	1	0	0	0	0	0	0	0	1	0	0	0
							R/W-	-808h							

#### Table 33. Register R26 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	808h	Program 808h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.28 Register R27 (offset = 1Bh) [reset = 0002h]

#### Figure 55. Register R27

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0
R/W-2h															

#### Table 34. Register R27 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	2h	Program 2h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.29 Register R28 (offset = 1Ch) [reset = 0488h]

#### Figure 56. Register R28

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	0	0	1	0	0	0	1	0	0	0
							R/W-	488h							

#### Table 35. Register R28 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	488h	Program 488h to this field.
				After programming R0 with RESET = 1, no need to program this register.

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## 7.6.30 Register R29 (offset = 1Dh) [reset = 18C6h]

#### Figure 57. Register R29

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/W-	18C6h	•			•			

#### Table 36. Register R29 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	18C6h	Program 0h to this field.

#### 7.6.31 Register R30 (offset = 1Eh) [reset = 18C6h]

#### Figure 58. Register R30

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	1	1	0	0	1	0	1	0	0	1	1	0
	•	•	•	•			R/W-	18C6h					•		

#### Table 37. Register R30 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	18C6h	Program CA6h to this field.

#### 7.6.32 Register R31 (offset = 1Fh) [reset = C3E6h]

#### Figure 59. Register R31

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
1	1	0	0	0	0	1	1	1	1	1	0	0	1	1	0
							R/W-0	C3E6h							

#### Table 38. Register R31 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	C3E6h	Program C3E6h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.33 Register R32 (offset = 20h) [reset = 05BFh]

#### Figure 60. Register R32

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	0	1	1	0	1	1	1	1	1	1
							R/W-	5BFh							

#### Table 39. Register R32 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	5BFh	Program 5BFh to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.34 Register R33 (offset = 21h) [reset = 1E01h]

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#### Figure 61. Register R33

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	1	1	1	1	0	0	0	0	0	0	0	0	1
							R/W-	IE01h							

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**TRUMENTS** 

#### Table 40. Register R33 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	1E01h	Program 1E01h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.35 Register R34 (offset = 22h) [reset = 0010h]

#### Figure 62. Register R34

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	1	0	F	PLL_N[18:16]	
	R/W-2h										R/W-0h				

#### Table 41. Register R34 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 3		R/W	2h	Program 2h to this field.
2 - 0	PLL_N[18:16]	R/W	0h	Upper 3 bits of N-divider.

#### 7.6.36 Register R35 (offset = 23h) [reset = 0004h]

#### Figure 63. Register R35

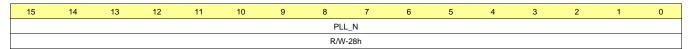
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
	R/W-4h														

#### Table 42. Register R35 Field Descriptions

Bit	Field	Туре	Reset	Description
15 -	)	R/W	4h	Program 4h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.37 Register R36 (offset = 24h) [reset = 0028h]

#### Figure 64. Register R36



#### Table 43. Register R36 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	PLL_N	R/W	28h	Lower 16 bits of N-divider.

#### 7.6.38 Register R37 (offset = 25h) [reset = 0205h]

### Figure 65. Register R37

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
MASH_S EED_EN	0	PFD_DLY_SEL							0	0	0	0	1	0	1
R/W-0h	R/W-0h			R/W	/-2h						R/V	V-5h			



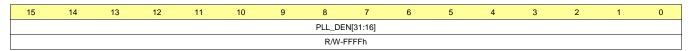
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#### Table 44. Register R37 Field Descriptions

Bit	Field	Туре	Reset	Description
15	MASH_SEED_EN	R/W	0h	Enables the MASH_SEED value to be used. This can be used for programmable phase stepping or fractional spur optimization.  0: Disabled  1: Enabled
14		R/W	0h	Program 0h to this field.
13 - 8	PFD_DLY_SEL	R/W	2h	PFD_DLY_SEL must be adjusted in accordance to the N-divider value. See Table 3 for details.
7 - 0		R/W	5h	Program 5h to this field.

#### 7.6.39 Register R38 (offset = 26h) [reset = FFFFh]

#### Figure 66. Register R38



#### Table 45. Register R38 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	PLL_DEN[31:16]	R/W	FFFFh	Upper 16 bits of fractional denominator (DEN).

#### 7.6.40 Register R39 (offset = 27h) [reset = FFFFh]

#### Figure 67. Register R39

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							PLL_DI	EN[15:0]							
							R/W-	FFFFh							

#### Table 46. Register R39 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	PLL_DEN[15:0]	R/W	FFFFh	Lower 16 bits of fractional denominator (DEN).

### 7.6.41 Register R40 (offset = 28h) [reset = 0000h]

#### Figure 68. Register R40



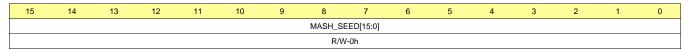
#### Table 47. Register R40 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	MASH_SEED[31:16]	R/W		Upper 16 bits of MASH_SEED. MASH_SEED sets the initial state of the fractional engine. Useful for producing a phase shift and fractional spur optimization.

#### 7.6.42 Register R41 (offset = 29h) [reset = 0000h]

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#### Figure 69. Register R41

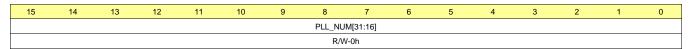


#### **Table 48. Register R41 Field Descriptions**

Bit	Field	Туре	Reset	Description	
15 - 0	MASH_SEED[15:0]	R/W	0h	Lower 16 bits of MASH_SEED. MASH_SEED sets the initial state of the fractional	
				engine. Useful for producing a phase shift and fractional spur optimization.	

#### 7.6.43 Register R42 (offset = 2Ah) [reset = 0000h]

#### Figure 70. Register R42

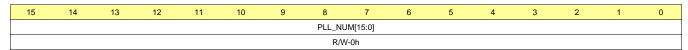


#### Table 49. Register R42 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	PLL_NUM[31:16]	R/W	0h	Upper 16 bits of fractional numerator (NUM).

#### 7.6.44 Register R43 (offset = 2Bh) [reset = 0000h]

#### Figure 71. Register R43



#### Table 50. Register R43 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	PLL_NUM[15:0]	R/W	0h	Lower 16 bits of fractional numerator (NUM).

#### 7.6.45 Register R44 (offset = 2Ch) [reset = 08A2h]

#### Figure 72. Register R44

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	OUTA_PWR						OUTB_P D	OUTA_P D	MASH_R ESET_N	0	0	MASH_ORDER		
R	R/W-0h R/W-08h					R/W-1h	R/W-0h	R/W-1h	R/V	V-0h		R/W-2h			

#### **Table 51. Register R44 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 14		R/W	0h	Program 0h to this field.
13 - 8	OUTA_PWR	R/W	08h	Adjusts RFoutA output power. Higher numbers give more output power. Values greater than 18 are prohibited.
7	OUTB_PD	R/W	1h	Powers down RF output B. 0: Normal operation 1: Power down
6	OUTA_PD	R/W	0h	Powers down RF output A. 0: Normal operation 1: Power down
5	MASH_RESET_N	R/W	1h	Resets MASH. 0: Reset 1: Normal operation
4 - 3		R/W	0h	Program 0h to this field.

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# Table 51. Register R44 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
2 - 0	MASH_ORDER	R/W	2h	Sets the MASH order. 0: Integer mode 1: First order modulator 2: Second order modulator 3: Third order modulator 4: Fourth order modulator 5 - 7: Not used

## 7.6.46 Register R45 (offset = 2Dh) [reset = C608h]

## Figure 73. Register R45

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
1	1	0	0	0	1	1	0	0	0	OUTB_PWR						
				R/W-	-318h							R/W	-08h			

#### Table 52. Register R45 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 6		R/W	318h	Program 318h to this field.
5 - 0	OUTB_PWR	R/W		Adjusts RFoutB output power. Higher numbers give more output power. Values greater than 18 are prohibited.

# 7.6.47 Register R46 (offset = 2Eh) [reset = 07F0h]

## Figure 74. Register R46

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	1	1	1	1	1	1	0	0	0	0
	R/W-7F0h														

## Table 53. Register R46 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W		Program 7F0h to this field.  After programming R0 with RESET = 1, no need to program this register.

# 7.6.48 Register R47 (offset = 2Fh) [reset = 0300h]

## Figure 75. Register R47

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	1	1	0	0	0	0	0	0	0	0
							R/W-	-300h							

## Table 54. Register R47 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	300h	Program 300h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.49 Register R48 (offset = 30h) [reset = 03E0h]

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## Figure 76. Register R48

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	1	1	1	1	1	0	0	0	0	0
							R/W-	3E0h							

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## Table 55. Register R48 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	3E0h	Program 3E0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.50 Register R49 (offset = 31h) [reset = 4180h]

# Figure 77. Register R49

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	1	0	0	0	0	0	1	1	0	0	0	0	0	0	0
	R/W-4180h														

## Table 56. Register R49 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	4180h	Program 4180h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.51 Register R50 (offset = 32h) [reset = 0080h]

# Figure 78. Register R50

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0
	R/W-80h														

#### Table 57. Register R50 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	80h	Program 80h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.52 Register R51 (offset = 33h) [reset = 0080h]

# Figure 79. Register R51

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0
							R/W	′-80h							

#### **Table 58. Register R51 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 0		R/W	80h	Program 80h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.53 Register R52 (offset = 34h) [reset = 0420h]

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## Figure 80. Register R52

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	1	0	0	0	0	1	0	0	0	0	1
R/W-420h															

## Table 59. Register R52 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	420h	Program 421h to this field.



# 7.6.54 Register R53 (offset = 35h) [reset = 0000h]

# Figure 81. Register R53

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
				•			R/V	/-0h	•			•		•	

## Table 60. Register R53 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.55 Register R54 (offset = 36h) [reset = 0000h]

## Figure 82. Register R54

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h														

## Table 61. Register R54 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.56 Register R55 (offset = 37h) [reset = 0000h]

## Figure 83. Register R55

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h														

#### Table 62. Register R55 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.57 Register R56 (offset = 38h) [reset = 0000h]

## Figure 84. Register R56

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							

#### Table 63. Register R56 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.58 Register R57 (offset = 39h) [reset = 0000h]

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## Figure 85. Register R57

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0
R/W-0h															

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# **Table 64. Register R57 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 20h to this field.

# 7.6.59 Register R58 (offset = 3Ah) [reset = 8001h]

# Figure 86. Register R58

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
INPIN_I GNORE	INPIN_H YST	INPIN	_LVL		INPIN_FMT		0	0	0	0	0	0	0	0	1
R/W-1h	R/W-0h	R/W	/-0h		R/W-0h						R/W-1h				

# Table 65. Register R58 Field Descriptions

Bit	Field	Туре	Reset	Description
15	INPIN_IGNORE	R/W	1h	Ignore SYNC and SysRefReq pins when VCO_PHASE_SYNC = 0. This bit should be set to 1 unless VCO_PHASE_SYNC = 1.
14	INPIN_HYST	R/W	0h	Enables high hysteresis for LVDS input to SysRefReq and SYNC pin. 0: Disabled 1: Enabled
13 - 12	INPIN_LVL	R/W	0h	Sets bias level for LVDS input to SysRefReq and SYNC pin. 0: Vin / 4 1: Vin 2: Vin / 2 3: Invalid
11 - 9	INPIN_FMT	R/W	Oh	Defines the input format of SysRefReq and SYNC pin.  0: SYNC = SysRefReq = CMOS  1: SYNC = LVDS; SysRefReq = CMOS  2: SYNC = CMOS; SysRefReq = LVDS  3: SYNC = SysRefReq = LVDS  4: SYNC = SysRefReq = CMOS  5: SYNC = LVDS (filtered); SysRefReq = CMOS  6: SYNC = CMOS; SysRefReq = LVDS (filtered)  7: SYNC = SysRefReq = LVDS (filtered)
8 - 0		R/W	1h	Program 1h to this field.

# 7.6.60 Register R59 (offset = 3Bh) [reset = 0001h]

## Figure 87. Register R59

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	LD_TYP E
							R/W-0h								R/W-1h

# Table 66. Register R59 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 1		R/W	0h	Program 0h to this field.
0	LD_TYPE	R/W	1h	Defines lock detect type.  0: VCOCal. Lock detect asserts a HIGH output after the VCO has finished calibration and the LD_DLY timeout counter is finished.  1: Vtune and VCOCal. Lock detect asserts a HIGH output when VCOCal lock detect would assert a HIGH signal and the tuning voltage to the VCO is within acceptable limits.

Product Folder Links: LMX2572LP

40



www.ti.com SNAS764 – MAY 2018

# 7.6.61 Register R60 (offset = 3Ch) [reset = 03E8h]

## Figure 88. Register R60

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							LD_	DLY							
							R/W-	3E8h							

## Table 67. Register R60 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	LD_DLY	R/W		For the VCOCal lock detect, this is the delay in ½ f <sub>PD</sub> cycles that is added after the calibration is finished before the VCOCal lock detect is asserted HIGH.

## 7.6.62 Register R61 (offset = 3Dh) [reset = 00A8h]

## Figure 89. Register R61

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	1	0	1	0	1	0	0	0
	R/W-A8h														

## Table 68. Register R61 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	A8h	Program A8h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.63 Register R62 (offset = 3Eh) [reset = 00AFh]

# Figure 90. Register R62

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
DBLBUF _EN_5	DBLBUF _EN_4	DBLBUF _EN_3	DBLBUF _EN_2	DBLBUF _EN_1	DBLBUF _EN_0	0	0	1	0	1	0	1	1	1	1
R/W-0h	R/W-0h	R/W-0h	R/W-0h	R/W-0h	R/W-0h					R/W	-AFh				

## Table 69. Register R62 Field Descriptions

Bit	Field	Туре	Reset	Description
15	DBLBUF_EN_5	R/W	0h	Enables double buffering for the MASH order. 0: Disabled 1: Enabled
14	DBLBUF_EN_4	R/W	0h	Enables double buffering for fractional numerator NUM. 0: Disabled 1: Enabled
13	DBLBUF_EN_3	R/W	0h	Enables double buffering for the integer portion of the N-divider. 0: Disabled 1: Enabled
12	DBLBUF_EN_2	R/W	0h	Enables double buffering for the Pre-R and Post-R dividers in the reference path.  Effective only if DBL_BUF_EN_3 = 1.  0: Disabled  1: Enabled
11	DBLBUF_EN_1	R/W	0h	Enables double buffering for the Multiplier in the reference path. Effective only if DBL_BUF_EN_3 = 1. 0: Disabled 1: Enabled
10	DBLBUF_EN_0	R/W	0h	Enables double buffering for the Doubler in the reference path. Effective only if DBL_BUF_EN_3 = 1. 0: Disabled 1: Enabled
9 - 0		R/W	AFh	Program AFh to this field.

#### 7.6.64 Register R63 (offset = 3Fh) [reset = 0000h]

#### Figure 91. Register R63

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h														

## Table 70. Register R63 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.65 Register R64 (offset = 40h) [reset = 1388h]

## Figure 92. Register R64

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	1	0	0	1	1	1	0	0	0	1	0	0	0
	R/W-1388h														

## Table 71. Register R64 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	1388h	Program 1388h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.66 Register R65 (offset = 41h) [reset = 0000h]

## Figure 93. Register R65

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/M	/-0h							

#### Table 72. Register R65 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.67 Register R66 (offset = 42h) [reset = 01F4h]

## Figure 94. Register R66

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	1	1	1	1	1	0	1	0	0
							R/W-	·1F4h							

#### Table 73. Register R66 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	1F4h	Program 1F4h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.68 Register R67 (offset = 43h) [reset = 0000h]

## Figure 95. Register R67

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	V-0h							



# Table 74. Register R67 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.69 Register R68 (offset = 44h) [reset = 03E8h]

# Figure 96. Register R68

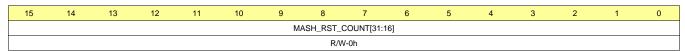
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	1	1	1	1	1	0	1	0	0	0
			•	•	•	•	R/W-	-3E8h			•	•			

## Table 75. Register R68 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	3E8h	Program 3E8h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.70 Register R69 (offset = 45h) [reset = 0000h]

## Figure 97. Register R69

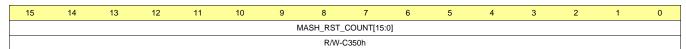


#### Table 76. Register R69 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	MASH_RST_COUNT [31:16]	R/W		Upper 16 bits of MASH_RST_COUNT. This register is used to add a delay when using phase SYNC. The delay should be set at least four times the PLL lock time. This delay is expressed in state machine clock periods. One of these periods is equal to $2^{\text{CAL\_CLK\_DIV}} / f_{\text{OSCin}}$ .

## 7.6.71 Register R70 (offset = 46h) [reset = C350h]

# Figure 98. Register R70



## Table 77. Register R70 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	MASH_RST_COUNT [15:0]	R/W	C350h	Lower 16 bits of MASH_RST_COUNT.

## 7.6.72 Register R71 (offset = 47h) [reset = 0080h]

#### Figure 99. Register R71



#### Table 78. Register R71 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	80h	Program 81h to this field.

# Instruments

## 7.6.73 Register R72 (offset = 48h) [reset = 0001h]

## Figure 100. Register R72

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1
			•	•			R/V	/-1h							

## Table 79. Register R72 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	1h	Program 1h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.74 Register R73 (offset = 49h) [reset = 003Fh]

## Figure 101. Register R73

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	1	1	1	1	1	1
							R/W	-3Fh							

## Table 80. Register R73 Field Descriptions

Bit	Field	Туре	Reset	Description				
15 - 0		R/W	3Fh	Program 3Fh to this field.				
				After programming R0 with RESET = 1, no need to program this register.				

## 7.6.75 Register R74 (offset = 4Ah) [reset = 0000h]

## Figure 102. Register R74

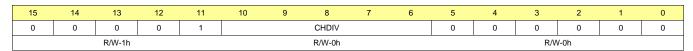
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/M	/-0h							

#### Table 81. Register R74 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.76 Register R75 (offset = 4Bh) [reset = 0800h]

## Figure 103. Register R75



#### Table 82. Register R75 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 11		R/W	1h	Program 1h to this field.
10 - 6	CHDIV	R/W	Oh	Channel divider. 0: Divide by 2 1: Divide by 4 3: Divide by 8 5: Divide by 16 7: Divide by 32 9: Divide by 64 12: Divide by 128 14: Divide by 256 All other values are not used.

Product Folder Links: LMX2572LP

44



# Table 82. Register R75 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
5 - 0		R/W	0h	Program 0h to this field.

## 7.6.77 Register R76 (offset = 4Ch) [reset = 000Ch]

#### Figure 104. Register R76

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	1	1	0	0
	R/W-Ch														

## Table 83. Register R76 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	Ch	Program Ch to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.78 Register R77 (offset = 4Dh) [reset = 0000h]

## Figure 105. Register R77

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h												•		

## **Table 84. Register R77 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.79 Register R78 (offset = 4Eh) [reset = 0064h]

# Figure 106. Register R78

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	RAMP_T HRESH[ 32]	0	QUICK_ RECAL_ EN				VCO_CAPO	TRL_STRT				1
	R/W	/-0h		R/W-0h	R/W-0h	R/W-0h				R/W	-32h				R/W-0h

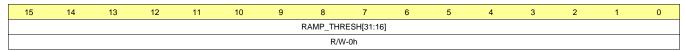
# Table 85. Register R78 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 12		R/W	0h	Program 0h to this field.
11	RAMP_THRESH[32]	R/W	0h	The $33^{rd}$ bit of RAMP_THRESH. RAMP_THRESH sets how much the ramp can change the VCO frequency before a VCO calibration is required. If the frequency is chosen to be $\Delta f$ , then RAMP_THRESH = $(\Delta f / f_{PD}) \times 2^{24}$ .
10		R/W	0h	Program 0h to this field.
9	QUICK_RECAL_EN	R/W	0h	This sets the initial VCO starting calibration values. Especially useful if the frequency change is smaller, say < 50 MHz or so.  0: Calibration starts with VCO_SEL, VCO_CAPCTRL_START, VCO_DACISET_START  1: Calibration starts with the current value
8 - 1	VCO_CAPCTRL_STRT	R/W	32h	This sets the starting VCO_CAPCTRL value that is used for VCO frequency calibration. Smaller values yield a higher frequency band within a VCO core. Valid number range is 0 to 183.
0		R/W	0h	Program 1h to this field.



# 7.6.80 Register R79 (offset = 4Fh) [reset = 0000h]

## Figure 107. Register R79

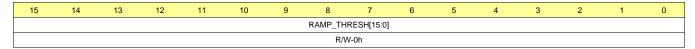


## Table 86. Register R79 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP_THRESH[31:16]	R/W	0h	Upper 16 bits of RAMP_THRESH. See Table 85 for description.

## 7.6.81 Register R80 (offset = 50h) [reset = 0000h]

#### Figure 108. Register R80



## Table 87. Register R80 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP_THRESH[15:0]	R/W	0h	Lower 16 bits of RAMP_THRESH. See Table 85 for description.

#### 7.6.82 Register R81 (offset = 51h) [reset = 0000h]

#### Figure 109. Register R81

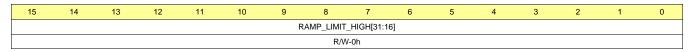
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	RAMP_L IMIT_HI GH[32]
	R/W-0h													R/W-0h	

#### **Table 88. Register R81 Field Descriptions**

Bit	Field	Туре	Reset	Description
15 - 1		R/W	0h	Program 0h to this field.
0	RAMP_LIMIT_HIGH[32]	R/W	Oh	The $33^{rd}$ bit of RAMP_LIMIT_HIGH. RAMP_LIMIT_HIGH sets a maximum frequency that the ramp cannot exceed so that the VCO does not get set beyond a valid frequency range. Suppose $f_{HIGH}$ is this frequency and $f_{VCO}$ is the starting VCO frequency, then: $f_{HIGH} \ge f_{VCO}$ ; RAMP_LIMIT_HIGH = $2^{24} \times (f_{HIGH} - f_{VCO}) / f_{PD}$

# 7.6.83 Register R82 (offset = 52h) [reset = 0000h]

## Figure 110. Register R82



## Table 89. Register R82 Field Descriptions

Bit	Field	Туре	Reset	Description
15 -	RAMP_LIMIT_HIGH [31:16]	R/W	0h	Upper 16 bits of RAMP_LIMIT_HIGH. See Table 88 for description.

Product Folder Links: LMX2572LP

**ISTRUMENTS** 



# 7.6.84 Register R83 (offset = 53h) [reset = 0000h]

## Figure 111. Register R83

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
	RAMP_LIMIT_HIGH[15:0]														
	R/W-0h														

## Table 90. Register R83 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP_LIMIT_HIGH[15:0]	R/W	0h	Lower 16 bits of RAMP_LIMIT_HIGH. See Table 88 for description.

## 7.6.85 Register R84 (offset = 54h) [reset = 0000h]

# Figure 112. Register R84

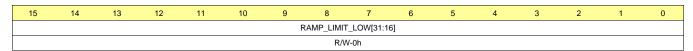
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	RAMP_L IMIT_LO W[32]
							R/W-0h								R/W-0h

## Table 91. Register R84 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 1		R/W	0h	Program 0h to this field.
0	RAMP_LIMIT_LOW[32]	R/W	Oh	The $33^{rd}$ bit of RAMP_LIMIT_LOW. RAMP_LIMIT_LOW sets a minimum frequency that the ramp cannot exceed so that the VCO does not get set beyond a valid frequency range. Suppose $f_{LOW}$ is this frequency and $f_{VCO}$ is the starting VCO frequency, then: $f_{LOW} \le f_{VCO}$ ; RAMP_LIMIT_LOW = $2^{33} - 2^{24} \times (f_{VCO} - f_{LOW}) / f_{PD}$

## 7.6.86 Register R85 (offset = 55h) [reset = 0000h]

#### Figure 113. Register R85



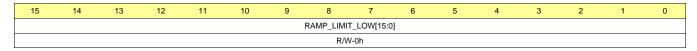
#### Table 92. Register R85 Field Descriptions

	Bit	Field	Туре	Reset	Description
1	5 - 0	RAMP_LIMIT_LOW [31:16]	R/W	0h	Upper 16 bits of RAMP_LIMIT_LOW. See Table 91 for description.

## 7.6.87 Register R86 (offset = 56h) [reset = 0000h]

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#### Figure 114. Register R86



#### Table 93. Register R86 Field Descriptions

I	Bit	Field	Туре	Reset	Description
15	5 - 0	RAMP_LIMIT_LOW[15:0]	R/W	0h	Lower 16 bits of RAMP_LIMIT_LOW. See Table 91 for description.

#### TEXAS INSTRUMENTS

## 7.6.88 Register R87 (offset = 57h) [reset = 0000h]

#### Figure 115. Register R87

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
R/W-0h															

## Table 94. Register R87 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

#### 7.6.89 Register R88 (offset = 58h) [reset = 0000h]

## Figure 116. Register R88

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							

## Table 95. Register R88 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.90 Register R89 (offset = 59h) [reset = 0000h]

## Figure 117. Register R89

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
R/W-0h															

#### Table 96. Register R89 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.91 Register R90 (offset = 5Ah) [reset = 0000h]

## Figure 118. Register R90

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							

#### **Table 97. Register R90 Field Descriptions**

Bit	Field	Туре	Reset	Description			
15 - 0		R/W	0h	Program 0h to this field.			
				After programming R0 with RESET = 1, no need to program this register.			

## 7.6.92 Register R91 (offset = 5Bh) [reset = 0000h]

## Figure 119. Register R91

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							



# Table 98. Register R91 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.93 Register R92 (offset = 5Ch) [reset = 0000h]

## Figure 120. Register R92

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h														

## Table 99. Register R92 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	0h	Program 0h to this field.
				After programming R0 with RESET = 1, no need to program this register.

## 7.6.94 Register R93 (offset = 5Dh) [reset = 0000h]

# Figure 121. Register R93

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							

#### Table 100. Register R93 Field Descriptions

Bit	Field	Туре	Reset	Description			
15 - 0		R/W	0h	Program 0h to this field.			
				After programming R0 with RESET = 1, no need to program this register.			

## 7.6.95 Register R94 (offset = 5Eh) [reset = 0000h]

#### Figure 122. Register R94

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R/V	/-0h							

#### Table 101. Register R94 Field Descriptions

Bit	Field	Туре	Reset	Description				
15 - 0		R/W	0h	Program 0h to this field.				
				After programming R0 with RESET = 1, no need to program this register.				

## 7.6.96 Register R95 (offset = 5Fh) [reset = 0000h]

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#### Figure 123. Register R95

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R/W-0h														

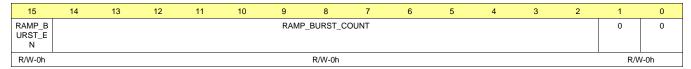
## Table 102. Register R95 Field Descriptions

Bit	Field	Туре	Reset	Description			
15 - 0		R/W	0h	Program 0h to this field.			
				After programming R0 with RESET = 1, no need to program this register.			



# 7.6.97 Register R96 (offset = 60h) [reset = 0000h]

#### Figure 124. Register R96



## Table 103. Register R96 Field Descriptions

Bit	Field	Туре	Reset	Description
15	RAMP_BURST_EN	R/W	Oh	This enables ramp burst mode. In this mode, a number of ramps equal to RAMP_BURST_COUNT is sent out whenever RAMP_EN is set to 1. This is intended to produce a finite pattern of ramps, instead of a continuous pattern.  0: Disabled  1: Enabled
14 - 2	RAMP_BURST_COUNT	R/W	0h	When RAMP_BURST_EN = 1, this sets the number of ramps that is sent out.
1 - 0		R/W	0h	Program 0h to this field.

# 7.6.98 Register R97 (offset = 61h) [reset = 0000h]

# Figure 125. Register R97

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
RAMP0_ RST	0	0	0	0		RAMP_	TRIGB			RAMP_	TRIGA		0	RAMP_BUI G	RST_TRI
R/W-0h		R/V	/-0h			R/W	/-0h			R/W	/-0h		R/W-0h	R/W-	-0h

# Table 104. Register R97 Field Descriptions

Bit	Field	Туре	Reset	Description
15	RAMP0_RST	R/W	0h	Resets RAMP0 at start of ramp to eliminate round-off errors. Applies to automatic ramping mode only. 0: Disabled 1: Reset
14 - 11		R/W	0h	Program 0h to this field.
10 - 7	RAMP_TRIGB	R/W	0h	Definition of ramp trigger B. 0: Disabled 1: RampClk pin rising edge 2: RampDir pin rising edge 4: Always triggered 9: RampClk pin falling edge 10: RampDir pin falling edge All other values are not used.
6 - 3	RAMP_TRIGA	R/W	0h	Definition of ramp trigger A. Options are same as RAMP_TRIGB.
2	_	R/W	0h	Program 0h to this field.
1 - 0	RAMP_BURST_TRIG	R/W	0h	Sets what triggers the next ramp in burst mode. 0: Ramp transition 1: Trigger A 2: Trigger B 3: Not used

# 7.6.99 Register R98 (offset = 62h) [reset = 0000h]

# Figure 126. Register R98

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
						RAMP0_I	NC[29:16]							0	RAMP0_ DLY
						R/V	/-0h							R/W-0h	R/W-0h



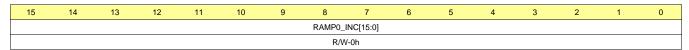
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## Table 105. Register R98 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 2	RAMP0_INC[29:16]	R/W	0h	Upper 14 bits of RAMP0_INC. RAMP0_INC sets the 2's compliment of the number added to the fractional numerator on every ramp cycle.
1		R/W	0h	Program 0h to this field.
0	RAMP0_DLY	R/W	0h	When enabled, increases RAMP0 length by basing the ramp clock on two phase detector cycles instead of one.  0: Ramp clock = 1 f <sub>PD</sub> cycle  1: Ramp clock = 2 f <sub>PD</sub> cycles

# 7.6.100 Register R99 (offset = 63h) [reset = 0000h]

## Figure 127. Register R99

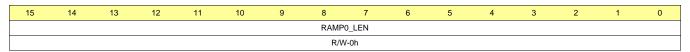


## Table 106. Register R99 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP0_INC[15:0]	R/W	0h	Lower 16 bits of RAMP0_INC. See Table 105 for description.

# 7.6.101 Register R100 (offset = 64h) [reset = 0000h]

# Figure 128. Register R100



# Table 107. Register R100 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP0_LEN	R/W	0h	Length of the ramp in phase detector cycles.

# 7.6.102 Register R101 (offset = 65h) [reset = 0000h]

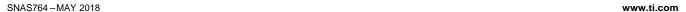
## Figure 129. Register R101

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	RAMP1_ DLY	RAMP1_ RST	RAMP0_ NEXT	0	0	RAMP0_N	IEXT_TRI
				R/W-0h					R/W-0h	R/W-0h	R/W-0h	R/V	V-0h	R/M	/-0h

## Table 108. Register R101 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 7		R/W	0h	Program 0h to this field.
6	RAMP1_DLY	R/W	0h	When enabled, increases RAMP1 length by basing the ramp clock on two phase detector cycles instead of one.  0: Ramp clock = 1 f <sub>PD</sub> cycle  1: Ramp clock = 2 f <sub>PD</sub> cycles
5	RAMP1_RST	R/W	0h	Resets RAMP1 at start of ramp to eliminate round-off errors. Applies to automatic ramping mode only.  0: Disabled 1: Reset
4	RAMP0_NEXT	R/W	0h	Defines what ramp comes after RAMP0. 0: RAMP0 1: RAMP1

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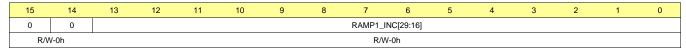


# Table 108. Register R101 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
3 - 2		R/W	0h	Program 0h to this field.
1 - 0	RAMP0_NEXT_TRIG	R/W	Oh	Defines what triggers the next ramp. 0: RAMPO_LEN timeout counter 1: Trigger A 2: Trigger B 3: Not used

## 7.6.103 Register R102 (offset = 66h) [reset = 0000h]

## Figure 130. Register R102

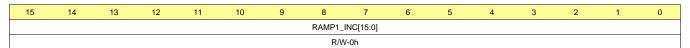


#### Table 109. Register R102 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 14		R/W	0h	Program 0h to this field.
13 - 0	RAMP1_INC[29:16]	R/W		Upper 14 bits of RAMP1_INC. RAMP1_INC sets the 2's compliment of the number added to the fractional numerator on every ramp cycle.

## 7.6.104 Register R103 (offset = 67h) [reset = 0000h]

#### Figure 131. Register R103

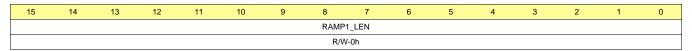


## Table 110. Register R103 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP1_INC[15:0]	R/W	0h	Lower 16 bits of RAMP1_INC. See Table 109 for description.

## 7.6.105 Register R104 (offset = 68h) [reset = 0000h]

#### Figure 132. Register R104



## Table 111. Register R104 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	RAMP1_LEN	R/W	0h	Length of the ramp in phase detector cycles.

## 7.6.106 Register R105 (offset = 69h) [reset = 4440h]

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## Figure 133. Register R105

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
RAMP_DLY_CNT										RAMP_ MANUAL	RAMP1_ NEXT	0	0		NEXT_TRI G
R/W-111h										R/W-0h	R/W-0h	R/V	V-0h	RΛ	N-0h



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## Table 112. Register R105 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 6	RAMP_DLY_CNT	R/W	111h	For ramping mode, RAMP_DLY_CNT and RAMP_SCALE_COUNT determine the minimum necessary time taken for VCO calibration during the ramp. Min. VCOCal time = (1 / $f_{smc}$ ) / (RAMP_DLY_CNT × $2^{RAMP\_SCALE\_COUNT}$ ), where $f_{smc} = f_{OSCin} / 2^{CAL\_CLK\_DIV}$ .
5	RAMP_MANUAL	R/W	0h	Selects the ramping mode. 0: Automatic ramping mode 1: Manual (Pin) ramping mode
4	RAMP1_NEXT	R/W	0h	Defines what ramp comes after RAMP1. 0: RAMP0 1: RAMP1
3 - 2		R/W	0h	Program 0h to this field.
1 - 0	RAMP1_NEXT_TRIG	R/W	0h	Defines what triggers the next ramp. 0: RAMP1_LEN timeout counter 1: Trigger A 2: Trigger B 3: Not used

# 7.6.107 Register R106 (offset = 6Ah) [reset = 0007h]

# Figure 134. Register R106

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	RAMP_T RIG_CA L	0	RAMP_	SCALE_C	OUNT
	R/W-0h											R/W-0h		R/W-7h	

# Table 113. Register R106 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 5		R/W	0h	Program 0h to this field.
4	RAMP_TRIG_CAL	R/W	0h	Enabling this bit causes VCO calibration to occur in automatic ramping mode at the beginning of each ramp. 0: Disabled 1: Enabled
3		R/W	0h	Program 0h to this field.
2 - 0	RAMP_SCALE_COUNT	R/W	7h	For ramping mode, RAMP_DLY_CNT and RAMP_SCALE_COUNT determine the minimum necessary time taken for VCO calibration during the ramp. Min. VCOCal time = (1 / $f_{smc}$ ) / (RAMP_DLY_CNT × $2^{RAMP\_SCALE\_COUNT}$ ), where $f_{smc}$ = $f_{OSCin}$ / $2^{CAL\_CLK\_DIV}$ .

## 7.6.108 Register R107 (offset = 6Bh) [reset = 0000h]

# Figure 135. Register R107



# Table 114. Register R107 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R	0h	Not used. (Read back only)

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## 7.6.109 Register R108 (offset = 6Ch) [reset = 0000h]

#### Figure 136. Register R108

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
	R-0h														

## Table 115. Register R108 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R	0h	Not used. (Read back only)

# 7.6.110 Register R109 (offset = 6Dh) [reset = 0000h]

# Figure 137. Register R109

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
							R-	0h							

# Table 116. Register R109 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R	0h	Not used. (Read back only)

## 7.6.111 Register R110 (offset = 6Eh) [reset = 0000h]

## Figure 138. Register R110

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	rb_LD_\	rb_LD_VTUNE		ı	rb_VCO_SEL		0	0	0	0	0
	R-0h														

# Table 117. Register R110 Field Descriptions

Bit	Field	Туре	Reset	Description
10 - 9	rb_LD_VTUNE	R	0h	Readback of Vtune lock detect. 0: Unlocked 1: Unlocked 2: Locked 3: Invalid
7 - 5	rb_VCO_SEL	R	Oh	Reads back the actual VCO that the calibration has selected.  1: VCO1  2: VCO2  6: VCO6 All other values are not used.

# 7.6.112 Register R111 (offset = 6Fh) [reset = 0000h]

# Figure 139. Register R111

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0				rb_VCO_0	CAPCTRL			
							R-	0h							

## Table 118. Register R111 Field Descriptions

Bit	Field	Туре	Reset	Description
7 - 0	rb_VCO_CAPCTRL	R	0h	Reads back the actual CAPCTRL value that the VCO calibration has chosen.



# 7.6.113 Register R112 (offset = 70h) [reset = 0000h]

## Figure 140. Register R112

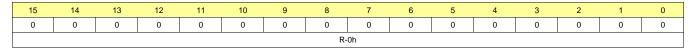
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0				rb_'	VCO_DACIS	SET			
							R-(	)h							

## Table 119. Register R112 Field Descriptions

Bit	Field	Туре	Reset	Description
8 - 0	rb_VCO_DACISET	R	0h	Reads back the actual DACISET value that the VCO calibration has chosen.

# 7.6.114 Register R113 (offset = 71h) [reset = 0000h]

## Figure 141. Register R113



# Table 120. Register R113 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R	0h	Not used. (Read back only)

# 7.6.115 Register R114 (offset = 72h) [reset = 7800h]

## Figure 142. Register R114

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	1	1	1	1	FSK_EN	0	FSK_I2S _FS_PO L		FSK_SPI	_LEVEL	FSK	_SPI_DEV_	SEL	FSK_MO	DE_SEL
		R/W-Fh			R/W-0h	R/W-0h	R/W-0h	R/W-0h	R/W	-0h		R/W-0h		R/W	/-0h

## Table 121. Register R114 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 11		R/W	Fh	Program Fh to this field.
10	FSK_EN	R/W	0h	Enables all FSK modes. 0: Disabled 1: Enabled
9		R/W	0h	Program 0h to this filed.
8	FSK_I2S_FS_POL	R/W	0h	Sets the polarity of the I2S Frame Sync input in FSK I2S mode. 0: Active HIGH 1: Active LOW
7	FSK_I2S_CLK_POL	R/W	0h	Sets the polarity of the I2S CLK input in FSK I2S mode. 0: Rising edge 1: Falling edge
6 - 5	FSK_SPI_LEVEL	R/W	Oh	Defines the desired FSK level in FSK SPI mode. When this bit is zero, FSK operation in this mode is disabled even if FSK_EN = 1.  0: Disabled 1: 2FSK 2: 4FSK 3: 8FSK
4 - 2	FSK_SPI_DEV_SEL	R/W	Oh	In FSK SPI mode, these bits select one of the FSK deviations as defined in registers R116 - R123. 0: FSK_DEV0 1: FSK_DEV1 7: FSK_DEV7

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## Table 121. Register R114 Field Descriptions (continued)

Bit	Field	Туре	Reset	Description
1 - 0	FSK_MODE_SEL	R/W		Defines FSK mode. 0: Not used 1: FSK I2S 2: FSK SPI 3: FSK SPI FAST

# 7.6.116 Register R115 (offset = 73h) [reset = 0000h]

#### Figure 143. Register R115

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	0		FSI	K_DEV_SCA	ALE		0	0	0
	R/W-0h									R/W-0h				R/W-0h	

## Table 122. Register R115 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 8		R/W	0h	Program 0h to this field.
7 - 3	FSK_DEV_SCALE	R/W	0h	The FSK deviation will be scaled by 2 <sup>FSK_DEV_SCALE</sup> .
2 - 0		R/W	0h	Program 0h to this field.

#### 7.6.117 Register R116 (offset = 74h) [reset = 0000h]

#### Figure 144. Register R116

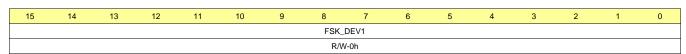
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							FSK_	DEV0							
							R/V	V-0h							

## Table 123. Register R116 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV0	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

## 7.6.118 Register R117 (offset = 75h) [reset = 0000h]

# Figure 145. Register R117



# Table 124. Register R117 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV1	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

## 7.6.119 Register R118 (offset = 76h) [reset = 0000h]

## Figure 146. Register R118

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							FSK_	DEV2							
							R/W	/-0h							

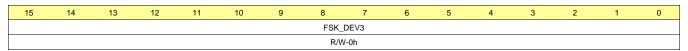


## Table 125. Register R118 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV2	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

#### 7.6.120 Register R119 (offset = 77h) [reset = 0000h]

## Figure 147. Register R119



# Table 126. Register R119 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV3	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

## 7.6.121 Register R120 (offset = 78h) [reset = 0000h]

#### Figure 148. Register R120

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							FSK_	DEV4							
							R/M	/-0h							

# Table 127. Register R120 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV4	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

## 7.6.122 Register R121 (offset = 79h) [reset = 0000h]

#### Figure 149. Register R121

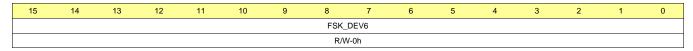
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
							FSK_	DEV5							
							R/W	/-0h							

## Table 128. Register R121 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV5	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

## 7.6.123 Register R122 (offset = 7Ah) [reset = 0000h]

## Figure 150. Register R122



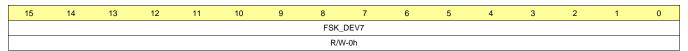
## Table 129. Register R122 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV6	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

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# 7.6.124 Register R123 (offset = 7Bh) [reset = 0000h]

## Figure 151. Register R123

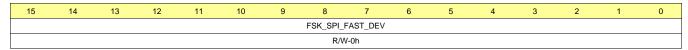


## Table 130. Register R123 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_DEV7	R/W	0h	Defines the desired frequency deviation in FSK SPI mode.

# 7.6.125 Register R124 (offset = 7Ch) [reset = 0000h]

# Figure 152. Register R124



# Table 131. Register R124 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0	FSK_SPI_FAST_DEV	R/W	0h	Defines the desired frequency deviation in FSK SPI FAST mode.

# 7.6.126 Register R125 (offset = 7Dh) [reset = 0820h]

## Figure 153. Register R125

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
0	0	0	0	1	0	0	0	0	0	1	0	0	0	0	0
	R/W-0820h														

# Table 132. Register R125 Field Descriptions

Bit	Field	Туре	Reset	Description
15 - 0		R/W	820h	Program 820h to this field.
				After programming R0 with RESET = 1, no need to program this register.

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NSTRUMENTS

SNAS764 - MAY 2018

# **Application and Implementation**

#### NOTE

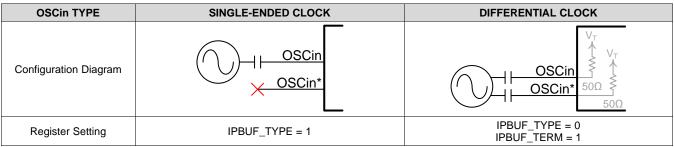
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#### 8.1 Application Information

#### 8.1.1 OSCin Configuration

OSCin supports single-ended and differential clock. Register R5 defines OSCin configuration.

Table 133. OSCin Configuration



Single-ended and differential input clock definitions are shown in Figure 154.

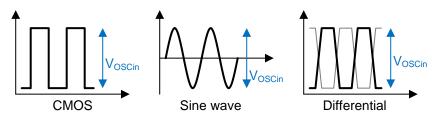


Figure 154. Input Clock Definition

#### 8.1.2 OSCin Slew Rate

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The slew rate of the OSCin signal can have an impact on the spurs and phase noise of the LMX2572LP if it is too low. In general, the best performance is for a high slew rate but a lower amplitude signal, such as LVDS.

#### 8.1.3 VCO Gain

The VCO gain varies between the six VCO cores and is the lowest at the lowest end of the band and highest at the highest end of each band. The typical VCO gain over each VCO core is listed in Table 134.

Table 134, VCO Gain

VCO CORE	f <sub>Min</sub> (MHz)	f <sub>Max</sub> (MHz)	K <sub>VCO</sub> Min (MHz/V)	K <sub>VCO</sub> Max (MHz/V)
VCO1	3200	3650	32	47
VCO2	3650	4200	35	54
VCO3	4200	4650	47	64
VCO4	4650	5200	50	73
VCO5	5200	5750	61	82
VCO6	5750	6400	57	79



TEXAS INSTRUMENTS

For an arbitrary VCO frequency, the VCO gain can be estimated as Equation 4:

$$K_{VCO} = K_{VCO}Min + (K_{VCO}Max - K_{VCO}Min) \times (f_{VCO} - f_{Min}) / (f_{Max} - f_{Min})$$
(4)

#### 8.1.4 VCO Calibration

The purpose of VCO calibration is to find out: (1) the correct VCO core, (2) the best band within the core, and (3) the best VCO amplitude setting. The LMX2572LP allows the user to assist the VCO calibration. In general, there are three kinds of assistance.

#### 8.1.4.1 Partial Assist

Upon every frequency change, before the FCAL\_EN bit is checked, the user provides a good estimate of the initial starting point for the VCO core (VCO\_SEL), band (VCO\_CAPCTRL\_STRT), and amplitude (VCO DACISET STRT). To do the partial assist for the VCO calibration, follow this procedure:

- 1. Pick a VCO core that includes the desired VCO frequency. If at the boundary of two cores, choose based on phase noise or performance.
- 2. Use Equation 5 to find the approximate band:

$$VCO\_CAPCTRL\_STRT = Round[C_{Min} - (f_{VCO} - f_{Min}) \times (C_{Min} - C_{Max}) / (f_{Max} - f_{Min})]$$
(5)

3. Use Equation 6 to find the approximate amplitude setting.

$$VCO\_DACISET\_STRT = Round[A_{Min} - (f_{VCO} - f_{Min}) \times (A_{Min} - A_{Max}) / (f_{Max} - f_{Min})]$$
(6)

VCO CORE	f <sub>Min</sub> (MHz)	f <sub>Max</sub> (MHz)	C <sub>Min</sub>	C <sub>Max</sub>	A <sub>Min</sub>	A <sub>Max</sub>
VCO1	3200	3650	131	19	138	137
VCO2	3650	4200	143	25	162	142
VCO3	4200	4650	135	34	126	114
VCO4	4650	5200	136	25	195	172
VCO5	5200	5750	133	20	190	163
VCO6	5750	6400	151	27	256	204

**Table 135. VCO Core Parametric** 

#### 8.1.4.2 Close Frequency Assist

Upon initialization of the device, the user enables the QUICK\_RECAL\_EN bit. The next VCO calibration will use the current VCO core, band, and amplitude settings as the initial starting point. This approach is useful if the frequency change is small, say 50 MHz or so.

#### 8.1.4.3 Full Assist

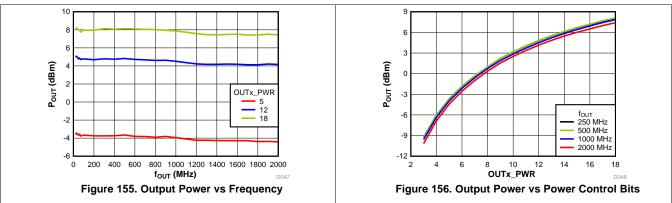
The user forces the VCO core (VCO\_SEL), band (VCO\_CAPCTRL), and amplitude (VCO\_DACISET) and manually sets the value. No VCO calibration will be performed. To force the set values, set VCO\_SEL\_FORCE, VCO\_CAPCTRL\_FORCE, and VCO\_DACISET\_FORCE equal 1. First do a VCO calibration and then read back the values to obtain the set values.

#### 8.1.5 Output Buffer Control

#### 8.1.5.1 Output Power

The OUTA\_PWR and OUTB\_PWR registers can be used to control the output power of the output buffers. Values greater than 18 are prohibited.





#### 8.1.5.2 Power-Up Response

Use the OUTx\_PD bits to power up or power down the output buffers. The RF output will vanish immediately when the buffer is powered down. However, it takes some tiny amount of time for it to power up.

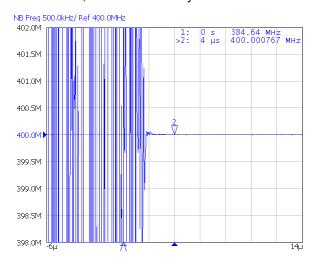


Figure 157. Buffer Power Up at 400-MHz Output

#### 8.1.5.3 Unused Output Pin

Each output buffer has two differential pair pins. The buffer can be used as a single differential output or two single-ended outputs. If only one single-ended output is necessary, the unused pin cannot be left open. The pin should be terminated properly as shown in Figure 158.

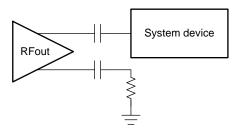


Figure 158. Unused Output Buffer Differential Pin

## 8.1.6 Application for SYNC

The requirements for SYNC depend on certain setup conditions. In cases where the SYNC is not timing critical, the setup can be done through software by toggling the VCO\_PHASE\_SYNC\_EN bit from 0 to 1. When the SYNC is timing critical, then setup must be done through the SYNC pin and the setup and hold times for the OSCin pin are critical.

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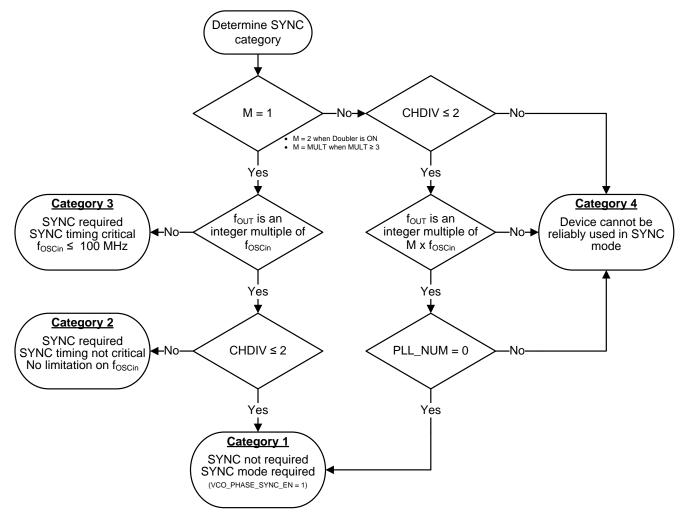


Figure 159. SYNC Category

The procedure for using SYNC in different SYNC categories is shown in Table 136.

Table 136. Procedure for Using SYNC

CATEGORY	CHARACTERISTIC	SETUP PROCEDURE
1	<ul><li>SYNC not required.</li><li>SYNC mode required.</li></ul>	<ol> <li>Set N = N' / 2, where N' is the normal N divider value.</li> <li>Program all the registers with R0 VCO_PHASE_SYNC_EN = 1.</li> </ol>
2	<ul> <li>SYNC required.</li> <li>SYNC timing not critical.</li> <li>No limitation on f<sub>OSCin</sub>.</li> </ul>	<ol> <li>Setup as usual.</li> <li>Program all the registers as usual. The device is now locked.</li> <li>Program N = N' / 2, where N' is the normal (original) N divider value.</li> <li>Program R0 with VCO_PHASE_SYNC_EN = 1.</li> <li>Program N = N'.</li> <li>Program R0 with VCO_PHASE_SYNC_EN = 0.</li> <li>Alternatively, step 3 to 6 can be replaced by applying a SYNC signal (0 → 1 transition) to the SYNC pin and the timing on this in not critical.</li> </ol>



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#### Table 136. Procedure for Using SYNC (continued)

CATEGORY	CHARACTERISTIC	SETUP PROCEDURE
	<ul><li>SYNC required.</li><li>SYNC timing critical.</li></ul>	Ensure that the maximum f <sub>OSCin</sub> for SYNC is not violated and there are hardware accommodations to use the SYNC pin.
3	• f <sub>OSCin</sub> ≤ 100 MHz	2. Set N = N' / 2, where N' is the normal N divider (integer + fraction) value.
3		Program all the registers with R0 VCO_PHASE_SYNC_EN = 1.
		<ol> <li>Apply a SYNC signal (0 → 1 transition) to the SYNC pin. The timing of the SYNC signal as shown in Timing Requirements must be obey.</li> </ol>

Set these bits to drive the SYNC pin with a LVDS signal:

- Set INPIN FMT to 1 or 3 to enable LVDS input
- Set INPIN\_LVL to one of the options
- · Set INPIN\_HYST, if necessary

The LVDS driver that is driving the SYNC pin should be configured as shown in Figure 160:

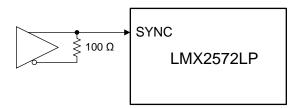


Figure 160. Driving SYNC Pin With Differential Signal

#### 8.1.7 Application for Ramp

#### 8.1.7.1 Manual Ramping Mode

Manual ramping is enabled when the user sets RAMP\_EN = 1 and RAMP\_MANUAL = 1. In this mode, the ramp is clocked by the rising edges applied to the RampClk pin. The size of the frequency change is defined by RAMP0\_INC and RAMP1\_INC. If a LOW is seen at the RampDir pin on the rising edge of RampClk, the output frequency will be incremented by RAMP0\_INC. On the contrary, the output frequency will be incremented by RAMP1\_INC if a HIGH is captured. If a rising edge is seen on the RampClk pin while the VCO is calibrating, then this rising edge is ignored. The frequency for the RampClk must be limited to a frequency of 250 kHz or less, and the rising edge of the RampDir signal must be targeted to the falling edge of the RampClk pin. The necessary register fields for use in manual ramping mode are shown in Table 137.

**Table 137. Manual Ramping Mode Programming** 

REGISTER FIELD	VALUE	DESCRIPTION	
RAMP_EN	1 = Enable ramp	Set this bit to 1 to enable frequency ramping.	
RAMP_MANUAL	1 = Manual ramping mode	To select manual ramping mode, set this bit to 1.	
RAMP_LIMIT_HIGH	Greater than the highest VCO ramp frequency	This sets the upper ramp limit that the ramp cannot go above. Suppose $f_{High}$ is this frequency and $f_{Start}$ is the starting VCO ramp frequency, then, for $f_{High} > f_{Start}$ , RAMP_LIMIT_HIGH = $2^{24} \times (f_{High} - f_{Start}) / f_{PD}$	
RAMP_LIMIT_LOW	Smaller than the lowest VCO ramp frequency	This sets the lower ramp limit that the ramp cannot go below. Suppose $f_{Low}$ is this frequency and $f_{Start}$ is the starting VCO ramp frequency, then, for $f_{Start} > f_{Low}$ , RAMP_LIMIT_LOW = $2^{33} - 2^{24} \times (f_{Start} - f_{Low}) / f_{PD}$	
RAMP0_INC RAMP1_INC	Equal to the ramp size	Suppose the ramp size is $\Delta f$ , then RAMPx_INC = $(\Delta f / f_{PD}) \times 2^{24}$ or = $2^{30} - (\Delta f / f_{PD}) \times 2^{24}$ if $\Delta f$ is a negative number.	
RAMP_THRESH	Suggest less than 50 MHz	If the amount of frequency ramp exceeds this threshold, a VCO calibration will be initiated. For example, if the ramp size is 50 MHz while this threshold is 30 MHz, then VCO calibration will be executed every time it ramps. Suppose the threshold frequency is $f_{TH}$ , then RAMP_THRESH = $(f_{TH}/f_{PD})\times 2^{24}$	

REGISTER FIELD	VALUE	DESCRIPTION
RAMP_TRIGA RAMP_TRIGB	1 = RampClk rising edge trigger	In manual ramping mode, the ramp is triggered by the rising edges applied to the RampClk pin.  Either RAMP_TRIGA or RAMP_TRIGB can be selected as the trigger source for the next ramp.
RAMP0_NEXT_TRIG RAMP1_NEXT_TRIG		These fields define what triggers the next ramp. They must be set to the same trigger source selected above.

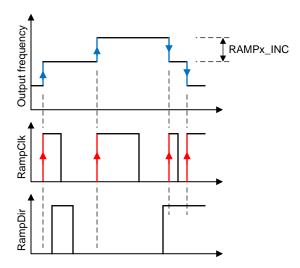


Figure 161. Manual Ramp Waveform

#### 8.1.7.2 Automatic Ramping Mode

Automatic ramping mode is enabled when RAMP\_EN = 1 with RAMP\_MANUAL = 0. In this mode, there are two ramps profiles that one can use to set the length and frequency change. In addition to this, there are ramp limits that can be used to create more complicated waveforms. The output frequency will ramp once on each phase detector cycle.

Automatic ramping can really be divided into two classes depending on whether the VCO must calibrate in the middle of the ramping or not. If the VCO can go the entire range without calibrating, this is calibration-free ramping. Note that this range is less at hot temperatures and less for lower frequency VCOs. This range is not ensured, so margin must be built into the design.

For ramping that are not calibration free, the ramp waveform is more like a staircase ramp.

**Table 138. Automatic Ramping Mode Programming** 

REGISTER FIELD	VALUE	DESCRIPTION	
RAMP_EN	1 = Enable ramp	Set this bit to 1 to enable frequency ramping.	
RAMP_MANUAL	0 = Automatic ramping mode	To select automatic ramping mode, set this bit to 0.	
RAMP_LIMIT_HIGH	Greater than the highest VCO ramp frequency	This sets the upper ramp limit that the ramp cannot go above. Suppose $f_{High}$ is this frequency and $f_{Start}$ is the starting VCO ramp frequency, then, for $f_{High} > f_{Start}$ , RAMP_LIMIT_HIGH = $2^{24} \times (f_{High} - f_{Start}) / f_{PD}$	
RAMP_LIMIT_LOW	Smaller than the lowest VCO ramp frequency	This sets the lower ramp limit that the ramp cannot go below. Suppose $f_{Low}$ is this frequency and $f_{Start}$ is the lowest VCO ramp frequency, then, for $f_{Start} > f_{Low}$ , RAMP_LIMIT_LOW = $2^{33} - 2^{24} \times (f_{Start} - f_{Low}) / f_{PD}$	
RAMP0_INC RAMP1_INC	Equal to the ramp size	Suppose the ramp size is $\Delta f$ , then RAMPx_INC = $(\Delta f / f_{PD}) \times 2^{24}$ or = $2^{30} - (\Delta f / f_{PD}) \times 2^{24}$ if $\Delta f$ is a negative number.	
RAMP_THRESH	Suggest less than 50 MHz	If the amount of frequency ramp exceed this threshold, a VCO calibration will be initiated. For example, if the ramp size is 15 MHz while this threshold is 20 MHz, then VCO calibration will be executed every two ramps. Suppose the threshold frequency is $f_{TH}$ , then RAMP_THRESH = $(f_{TH}/f_{PD})\times 2^{24}$	



#### Table 138. Automatic Ramping Mode Programming (continued)

REGISTER FIELD	VALUE	DESCRIPTION
RAMP0_LEN RAMP1_LEN	0 to 2 <sup>16</sup>	Set the number of ramp required in each ramp profile. Maximum value is $2^{16}$ . If this number is exceeded, enable the RAMPx_DLY bit or reduce the phase detector frequency. RAMPx_LEN = Ramp duration of a ramp profile $\times$ f <sub>PD</sub>
RAMP0_DLY RAMP1_DLY	0 or 1	If this bit is set to 1, the output frequency will ramp every two f <sub>PD</sub> cycles.
RAMP0_NEXT RAMP1_NEXT	Equal to the next ramp	Set the next ramping profile when the present profile is finished.
RAMP0_NEXT_TRIG RAMP1_NEXT_TRIG	0 = RAMP_LENx time out counter	Set these bits to 0 in order to start the next ramp immediately after the previous ramp.
RAMP0_RST RAMP1_RST	0 or 1	If the stop frequency of the present ramp profile is different from the start frequency of the next ramp profile, set this bit to 1.
RAMP_SCALE_COU NT RAMP_DLY_CNT	Suggest a minimum pause time of 50 µs	These two register fields set the minimum pause time when RAMP_THRESH is hit. This pause time must be sufficient to allow the VCO to complete a calibration, otherwise it will be overwritten by the actual VCO calibration time.  Minimum pause time = RAMP_DLY_CNT × 2 <sup>RAMP_SCALE_COUNT</sup> × 2 <sup>CAL_CLK_DIV</sup> / f <sub>OSCin</sub>

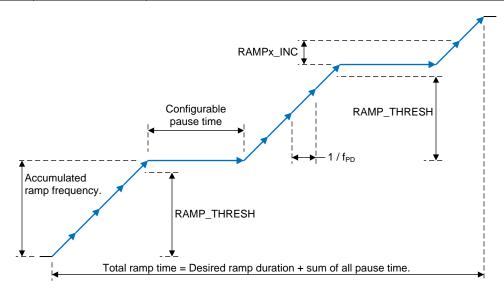


Figure 162. Auto Ramp Waveform

#### 8.1.8 Application for FSK

In fractional mode, the finest delta frequency difference between two programmable output frequencies is equal to Equation 7:

$$f_1 - f_2 = \Delta f_{min} = f_{PD} \times \{ [(PLL_N + 1) / PLL_DEN] - (PLL_N / PLL_DEN) \} = f_{PD} / PLL_DEN$$
 (7)

In other words, when the fractional numerator is incremented by 1 (one step), the output frequency will change by  $\Delta f_{min}$ . A two steps increment will therefore change the frequency by  $2 \times \Delta f_{min}$ .

In FSK operation, the instantaneous carrier frequency is kept changing among some pre-defined frequencies. In general, the instantaneous carrier frequency is defined as a certain frequency deviation from the nominal carrier frequency. The frequency deviation could be positive and negative.

(9)

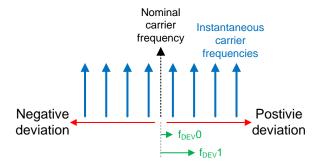


Figure 163. General FSK Definition

Equation 8 and Equation 9 define the number of steps required for the desired frequency deviation with respect to the nominal carrier frequency output. Assume  $\Delta f_{DEV}$  is the frequency deviation,

For positive deviation, FSK step = Round[
$$(\Delta f_{DEV} \times PLL_DEN \times CHDIV) / (f_{PD} \times 2^{FSK_DEV_SCALE})$$
] (8)

For negative deviation, FSK step =  $2^{16}$  – the positive deviation, FSK step answer

In FSK SPI mode, registers R116 – R123 are used to store the desired FSK steps as defined in Equation 8 and Equation 9. The order of the registers, 0 to 7, depends on the application system. A typical 4FSK definition is shown in Figure 164. In this case, the FSK\_DEV0 and FSK\_DEV1 are calculated using Equation 8, while the FSK DEV2 and FSK DEV3 are calculated using Equation 9.

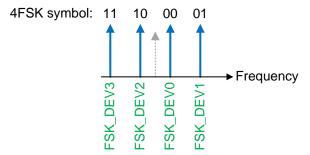


Figure 164. Typical 4FSK Definition

FSK SPI mode assumes the user knows which symbol to send. The user can directly write to FSK\_SPI\_DEV\_SEL to select the desired frequency deviation. For example, to enable the device to support 4FSK modulation in FSK SPI mode, set:

- FSK\_MODE\_SEL = 2 (FSK SPI)
- FSK SPI LEVEL = 2 (4FSK)
- FSK\_EN = 1

Table 139. FSK SPI Mode Example

DESIRED SYMBOL	WRITE REGISTER FSK_SPI_DEV_SEL	REGISTER SELECTED
10	2	FSK_DEV2
11	3	FSK_DEV3
10	2	FSK_DEV2
11	3	FSK_DEV3
01	1	FSK_DEV1
00	0	FSK_DEV0



FSK SPI mode supports up to eight levels of FSK. To support an arbitrary-level FSK, use FSK SPI FAST mode. Constructing pulse-shaping FSK modulation by over-sampling the FSK modulation waveform is one of the used cases of this mode.

Analog-FM modulation can also be produced in this mode. For example, with a 1-kHz sine wave modulation signal with peak frequency deviation of ±2 kHz, the signal can be oversampled, say 10 times. Each sample point corresponding to a scaled frequency deviation.

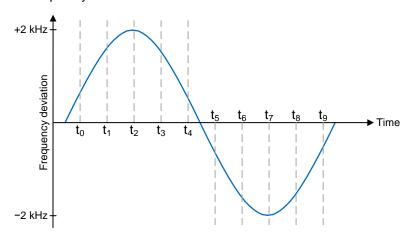


Figure 165. Oversampling Modulation Signal

In FSK SPI FAST mode, write the desired FSK steps directly to FSK\_SPI\_FAST\_DEV. To enable this mode, set:

- FSK\_MODE\_SEL = 3 (FSK SPI FAST)
- FSK EN = 1

Table 140. FSK SPI FAST Mode Example

			•	
TIME	FREQUENCY DEVIATION (Hz)	CORRESPONDING FSK STEPS <sup>(1)</sup>	BINARY EQUIVALENT	WRITE TO FSK_SPI_FAST_DEV
t <sub>0</sub>	618.034	396	0000 0001 1000 1100	396
t <sub>1</sub>	1618.034	1036	0000 0100 0000 1100	1036
t <sub>2</sub>	2000	1280	0000 0101 0000 0000	1280
t <sub>6</sub>	-1618.034	64500	1111 1011 1111 0011	64500
t <sub>7</sub>	-2000	64256	1111 1010 1111 1111	64256

<sup>(1)</sup>  $f_{VCO} = 3840 \text{ MHz}, f_{OUT} = 480 \text{ MHz}, f_{PD} = 100 \text{ MHz}, CHDIV = 8, PLL_DEN = 8000000, FSK_DEV_SCALE = 0.$ 

Block Programming is possible with FSK SPI FAST mode programming as long as ADD HOLD = 1, which will freeze the register address after the first register write. The same programming sequent as shown in Figure 27 applies.

In FSK I2S mode, clock in the desired binary format FSK steps in the I2S interface.

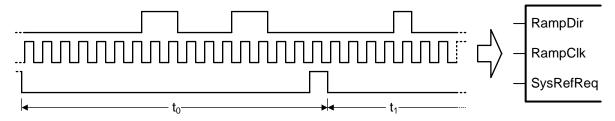


Figure 166. FSK I2S Mode Example

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To enable FSK I2S mode, set

- INPIN IGNORE = 0
- FSK\_MODE\_SEL = 1 (FSK I2S)
- FSK EN = 1

#### 8.1.9 Unused Pins

TI recommends to pull these pins low if they are not used:

- Pin 5, SYNC
- Pin 28, SysRefReg
- Pin 30, RampClk
- Pin 32, RampDir

#### 8.1.10 External Loop Filter

The LMX2572LP requires an external loop filter that is application-specific and can be configured by PLLatinum Sim. For the LMX2572LP, it matters what impedance is seen from the Vtune pin looking outwards. This impedance is dominated by the component C3 for a third order filter or C1 for a second order filter. If there is at least 1.5 nF for the capacitance that is shunt with this pin, the VCO phase noise will be close to the best it can be. If there is less, the VCO phase noise in the 100-kHz to 1-MHz region will degrade. This capacitor should be placed close to the Vtune pin.

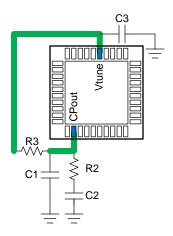


Figure 167. External Loop Filter

#### 8.1.11 Power-Up, Wake-Up Time

When the device comes out of the powered-down state, either by resuming the POWERDOWN bit to zero or by pulling back CE pin HIGH (if it was powered down by CE pin), it takes time for the device to acquire lock again. This wake-up time depends on LDO\_DLY setting, loop bandwidth, and the state machine clock frequency (=  $f_{OSCin} / 2^{CAL\_CLK\_DIV}$ ). If the loop bandwidth is greater than 20 kHz, the wake-up time could be adjusted to less than 1.5 ms with the LDO\_DLY setting listed in Table 141.

Table 141. LDO DLY Setting

STATE MACHINE CLOCK FREQUENCY	LDO_DLY
130 MHz ≤ f ≤ 200MHz	8
80 MHz ≤ f < 130 MHz	5
50 MHz ≤ f < 80 MHz	3
30 MHz ≤ f < 50 MHz	2
f < 30 MHz	1

Submit Documentation Feedback

Product Folder Links: LMX2572LP

8.2 Typical Application

This application example demonstrates how to set up the LMX2572LP in FSK SPI FAST mode to synthesize 4-level GFSK modulation.

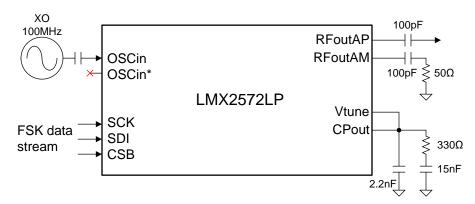


Figure 168. Application Example Schematic

#### 8.2.1 Design Requirements

Table 142 lists the design parameters for this example.

PARAMETER

OSCin frequency

RFout frequency

490 MHz

4FSK modulation baud rate

BT of Gaussian filter

FSK frequency deviation

EXAMPLE VALUE

100 MHz

490 MHz

495 KSps

0.4

EXAMPLE VALUE

100 MHz

490 MHz

417 kSps

125 kSps

127 kHz and ±51 kHz

8000000

Table 142. Design Parameters

#### 8.2.2 Detailed Design Procedure

First, determine all the elementary blocks of a synthesizer.

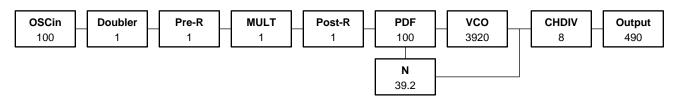


Figure 169. Application Example Frequency Plan

Then, program these registers to make LMX2572LP locks to the target output frequency:

Fractional denominator

- OSC\_2X = 0
- PLL\_R\_PRE = 1
- MULT = 1
- PLL\_R = 1
- PLL\_N[18:16] = 0; PLL\_N[15:0] = 39
- PLL\_NUM[31:16] = 24; PLL\_NUM[15:0] = 27136
- PLL\_DEN[31:16] = 122; PLL\_DEN[15:0] = 4680
- CHDIV = 8

Then program these registers to enable FSK SPI FAST mode:

• FSK MODE SEL = 3

TEXAS INSTRUMENTS

- FSK\_DEV\_SCALE = 1
- FSK\_EN = 1

A Mathlab script is then developed to generate the necessary codes that will be used to continuously bit-stream the LMX2572LP. These codes are uploaded to the data generator DG2020, which will generate the SPI data to *modulate* the LMX2572LP.

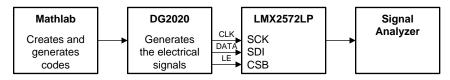
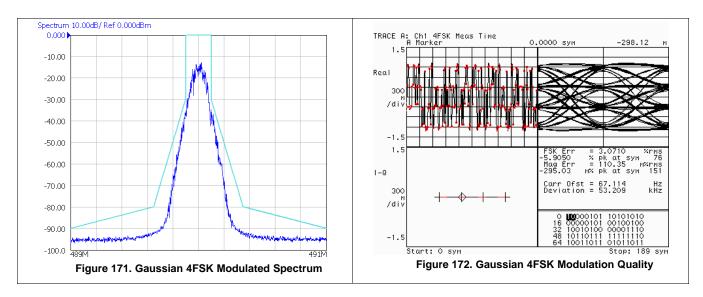


Figure 170. Application Example Test Setup

## 8.2.3 Application Curves



#### 8.3 Do's and Don'ts

- RFout output buffers do not need an external pullup. An AC-couple to the load is good enough.
- The last shunt capacitor of the loop filter should be placed close to the Vtune pin.

70



# Do's and Don'ts (continued)

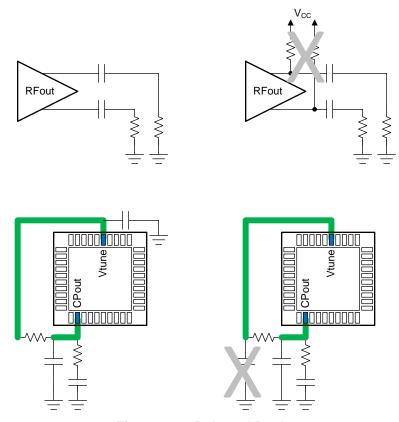


Figure 173. Do's and Don'ts



## 9 Power Supply Recommendations

TI recommends placing a 100-nF capacitor close to each of the power supply pins. If fractional spurs are a large concern, use a ferrite bead to each of these power supply pins to reduce spurs to a small degree. This device has integrated LDOs, which improves the resistance to power supply noise. Figure 174 is a typical application example.

This device can be powered by an external DC/DC buck converter, such as the TPS62150. Note that although Rtps1 and Rtps2 are 1.5  $\Omega$  in the schematic, they could be potentially replaced with a larger resistor value or inductor value for better power supply filtering. Alternatively, the use of a larger capacitance value for C2 and C4 could also result in better power supply filtering.

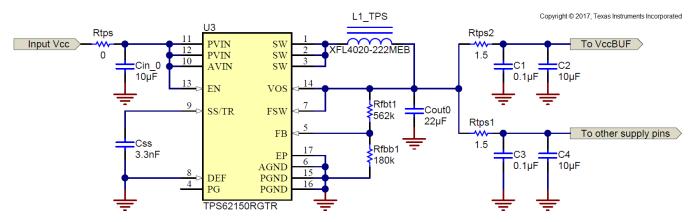
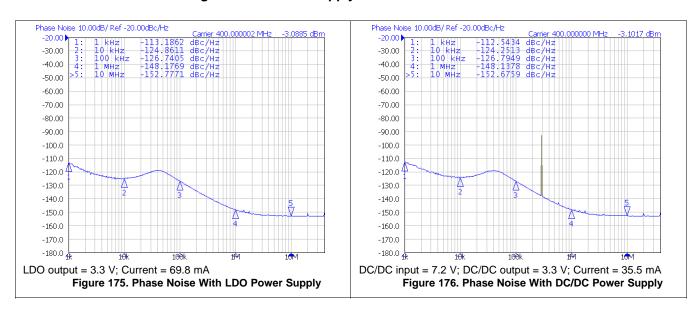


Figure 174. Power Supply With a DC/DC Converter



The power consumption of LMX2572LP depends on its configuration. The data as shown in the *Electrical Characteristics* table represent the current consumption at some specific conditions. It is possible to get a smaller or higher current consumption than what is specified in the data sheet. To get a rough estimation on current consumption at a particular configuration, use TICS Pro.

72



## 10 Layout

#### 10.1 Layout Guidelines

In general, the layout guidelines are similar to most other PLL devices. Here are some specific guidelines:

- GND pins may be routed on the package back to the DAP.
- The OSCin pins are internally biased and must be AC-coupled.
- The RampClk, RampDir, and SysRefReq can be grounded to the DAP if not used.
- Get a loop filter capacitor as close to the Vtune pin as possible to this. This may mean separating it from the rest of the loop filter.
- If a single-ended output is necessary, the other side must have the same loading. However, the routing for the used side can be optimized by routing the complementary side through a via to the other side of the board. On this side, make the load look equivalent to the side that is used.
- Ensure the DAP on the device is well-grounded with many vias, preferably copper filled.
- Have a thermal pad that is as large as the exposed pad. Add vias to the thermal pad to maximize thermal
  performance.

#### 10.2 Layout Example

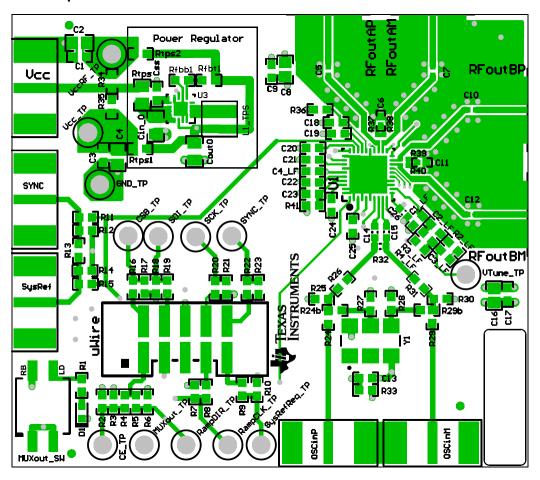


Figure 177. Layout Example

# TEXAS INSTRUMENTS

#### 11 Device and Documentation Support

## 11.1 Device Support

#### 11.1.1 Development Support

Texas Instruments has several software tools to aid in the development at www.ti.com. Among these tools are:

- PLLatinum Sim program for designing loop filters, simulating phase noise and spurs.
- TICS Pro software to understand how to program the device and for programming the EVM board.

#### 11.2 Documentation Support

#### 11.2.1 Related Documentation

For related documentation see the following:

- TPS62150 3–17V 1A Step-Down Converter With DCS-Control (SLVSAL5)
- AN-1879 Fractional N Frequency Synthesis (SNAA062)
- Frequency Shift Keying With LMX2571 (SNAA309)
- PLL Performance, Simulation, and Design Handbook (SNAA106)
- LMX2572LPEVM User's Guide (SNAU235)

#### 11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 11.4 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community T's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 11.5 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 11.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

74



# PACKAGE OPTION ADDENDUM

6-Jun-2018

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	_	Pins	_		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
LMX2572LPRHAR	ACTIVE	VQFN	RHA	40	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	LMX2572 LP	Samples
LMX2572LPRHAT	ACTIVE	VQFN	RHA	40	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 85	LMX2572 LP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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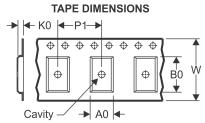
6-Jun-2018

# PACKAGE MATERIALS INFORMATION

www.ti.com 2-Jun-2018

# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

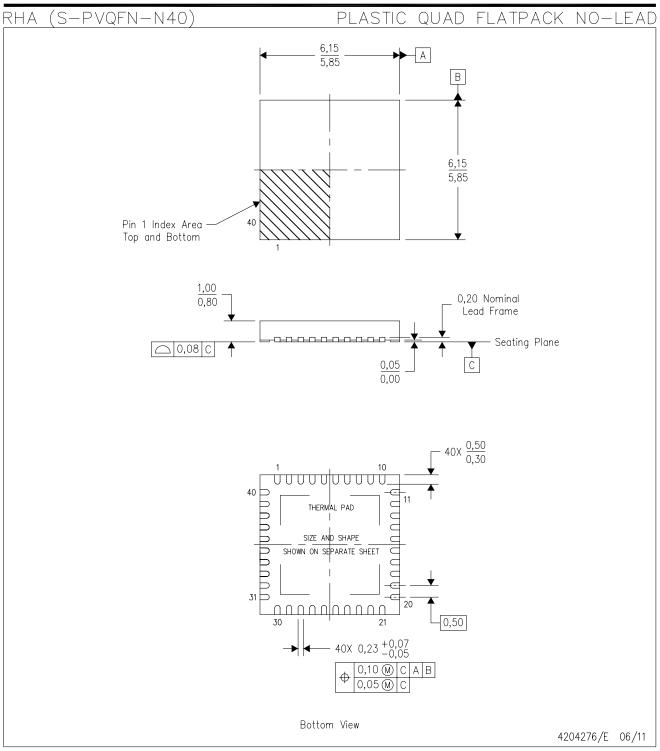
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMX2572LPRHAR	VQFN	RHA	40	2500	330.0	16.4	6.3	6.3	1.5	12.0	16.0	Q2
LMX2572LPRHAT	VQFN	RHA	40	250	178.0	16.4	6.3	6.3	1.5	12.0	16.0	Q2

www.ti.com 2-Jun-2018



#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
LMX2572LPRHAR	VQFN	RHA	40	2500	367.0	367.0	38.0
LMX2572LPRHAT	VQFN	RHA	40	250	210.0	185.0	35.0



- NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
  - B. This drawing is subject to change without notice.
  - C. QFN (Quad Flatpack No-Lead) Package configuration.
  - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - F. Package complies to JEDEC MO-220 variation VJJD-2.



# RHA (S-PVQFN-N40)

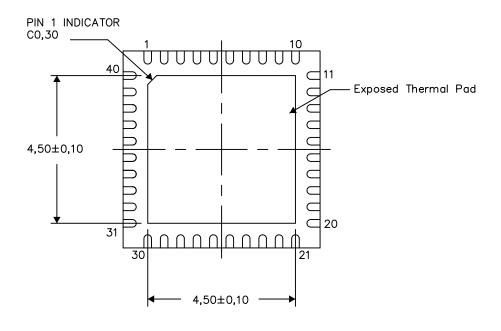
# PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

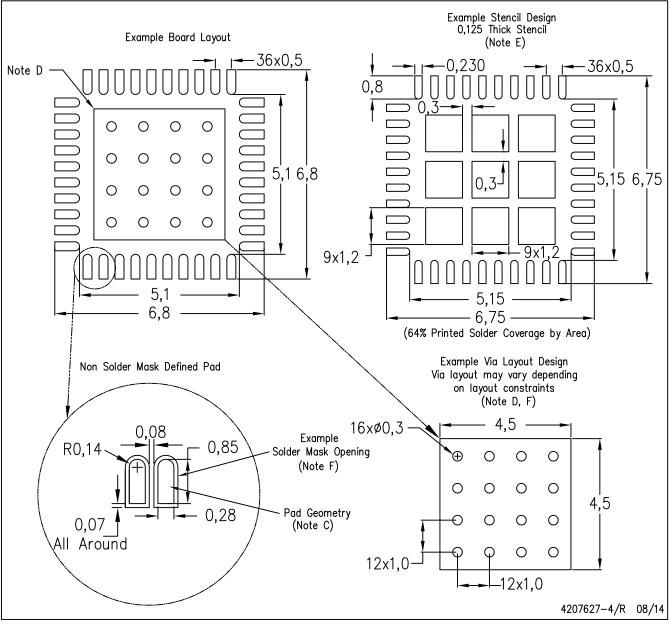
4206355-4/X 08/14

NOTES: A. All linear dimensions are in millimeters



# RHA (S-PVQFN-N40)

# PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for vias placed in the thermal pad.



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